



Introduction to Image Analysis

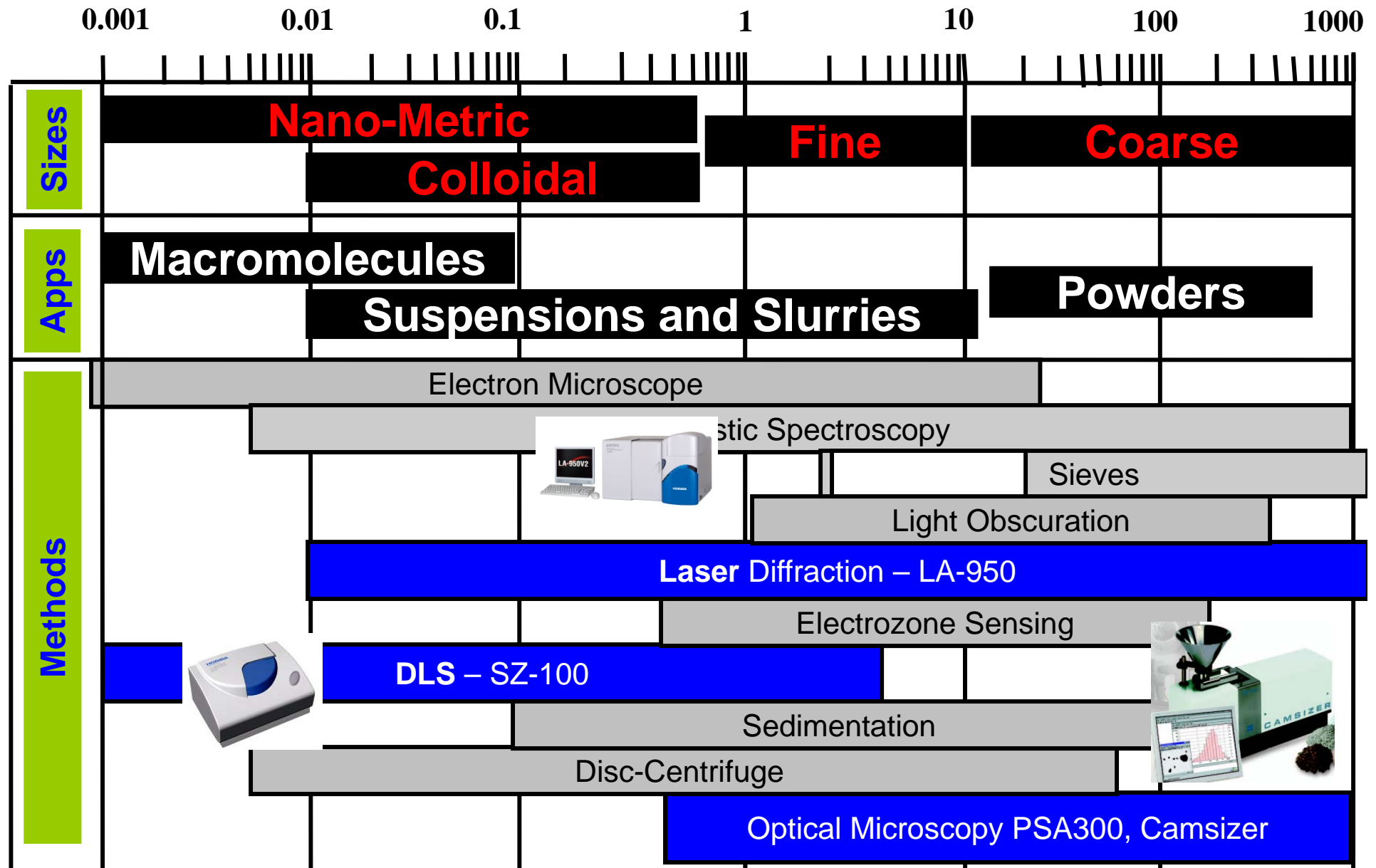


Jeffrey Bodycomb, Ph.D.

HORIBA Scientific

www.horiba.com/us/particle

Size: Particle Diameter (μm)



Why image analysis?

- Replace sieves (really!)
- Verify/supplement laser diffraction results (orthogonal technique).
- Need shape information, for example due to importance of powder flow

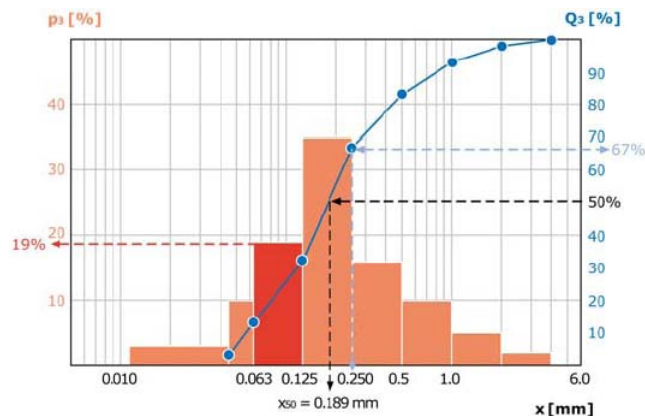
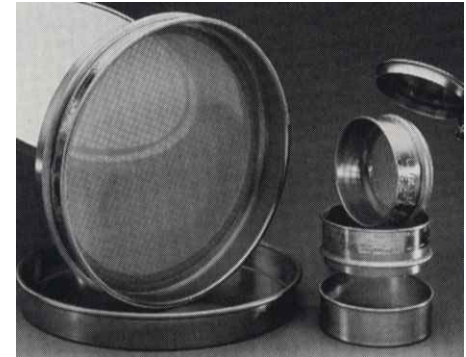


These may have the same size (cross section), but behave very differently.

Why image analysis?

Replace Sieves

- Tend to wear over time. It is difficult to tell when sieve results are “drifting” due to wear
- Results depend on nature of shaking and loading leading to operator to operator variations in results.
- Small number of size classes



Size class [mm]	p_3 [%]	Q_3 [%]
< 0.045	3.0	3.0
0.045 - 0.063	10.0	13.0
0.063 - 0.125	19.0	32.0
0.125 - 0.250	35.0	67.0
0.250 - 0.500	16.0	83.0
0.500 - 1.000	10.0	93.0
1.000 - 2.000	5.0	98.0
2.000 - 4.000	2.0	100.0
> 4.000	0.0	100.0

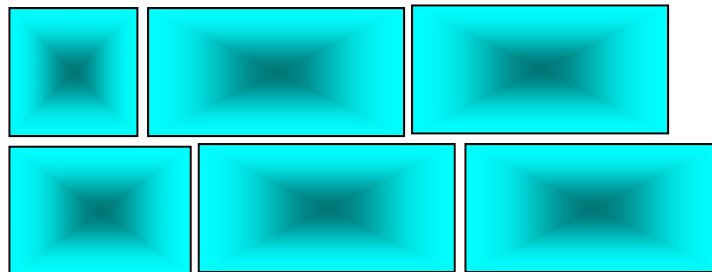
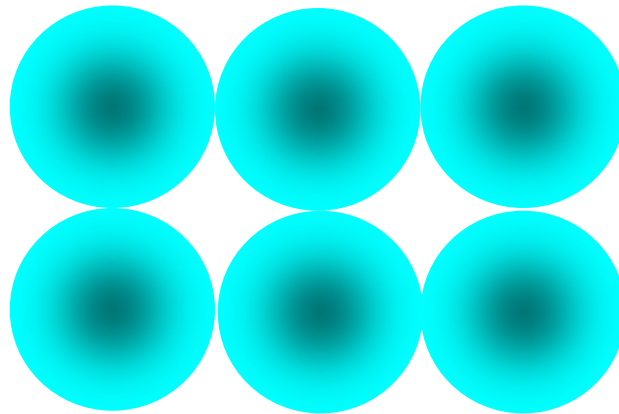
$x_{50} = 0.189 \text{ mm}$



More information available through www.retsch.com

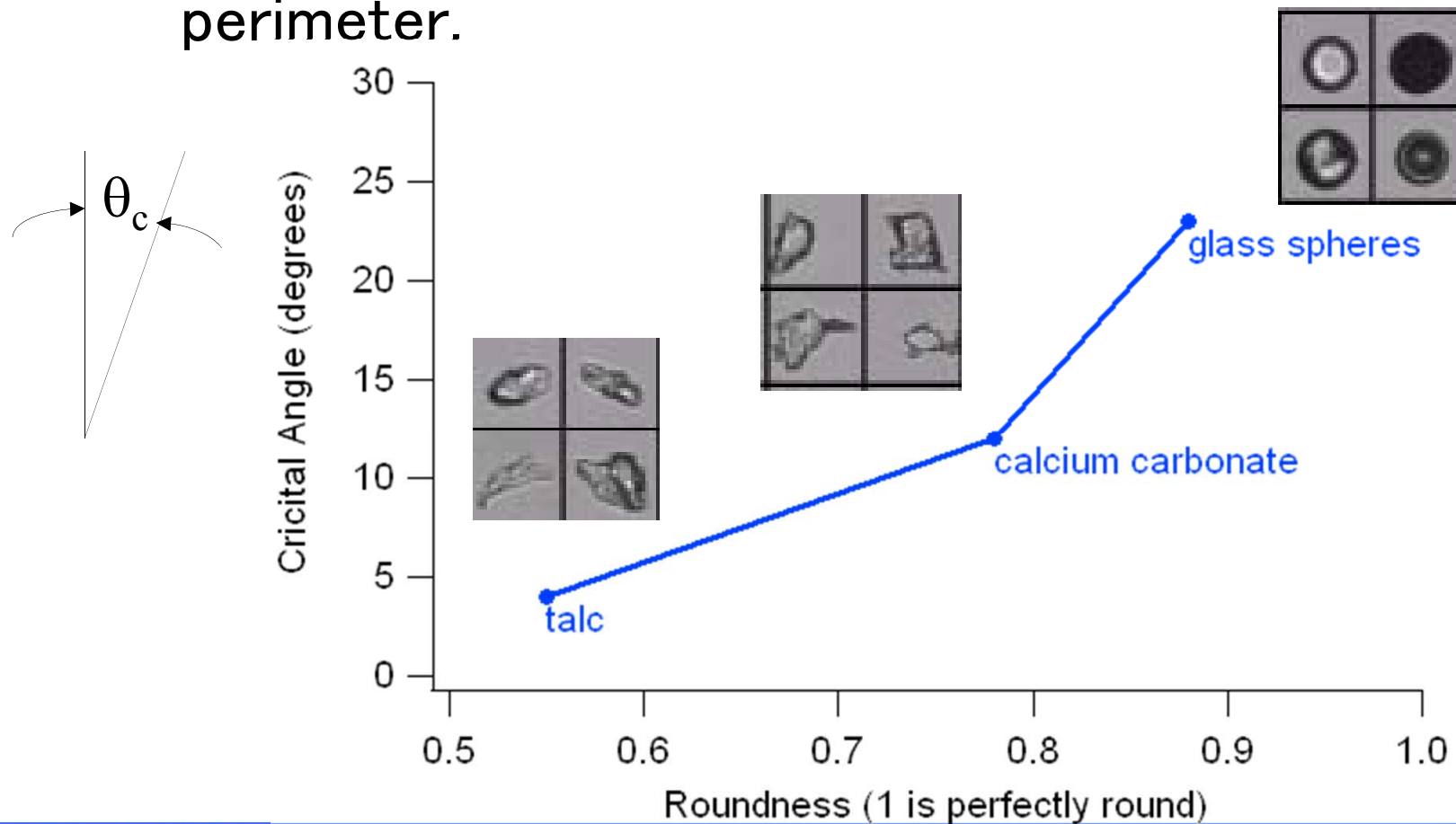
Why image analysis?

Need shape information for evaluating packing and flow.



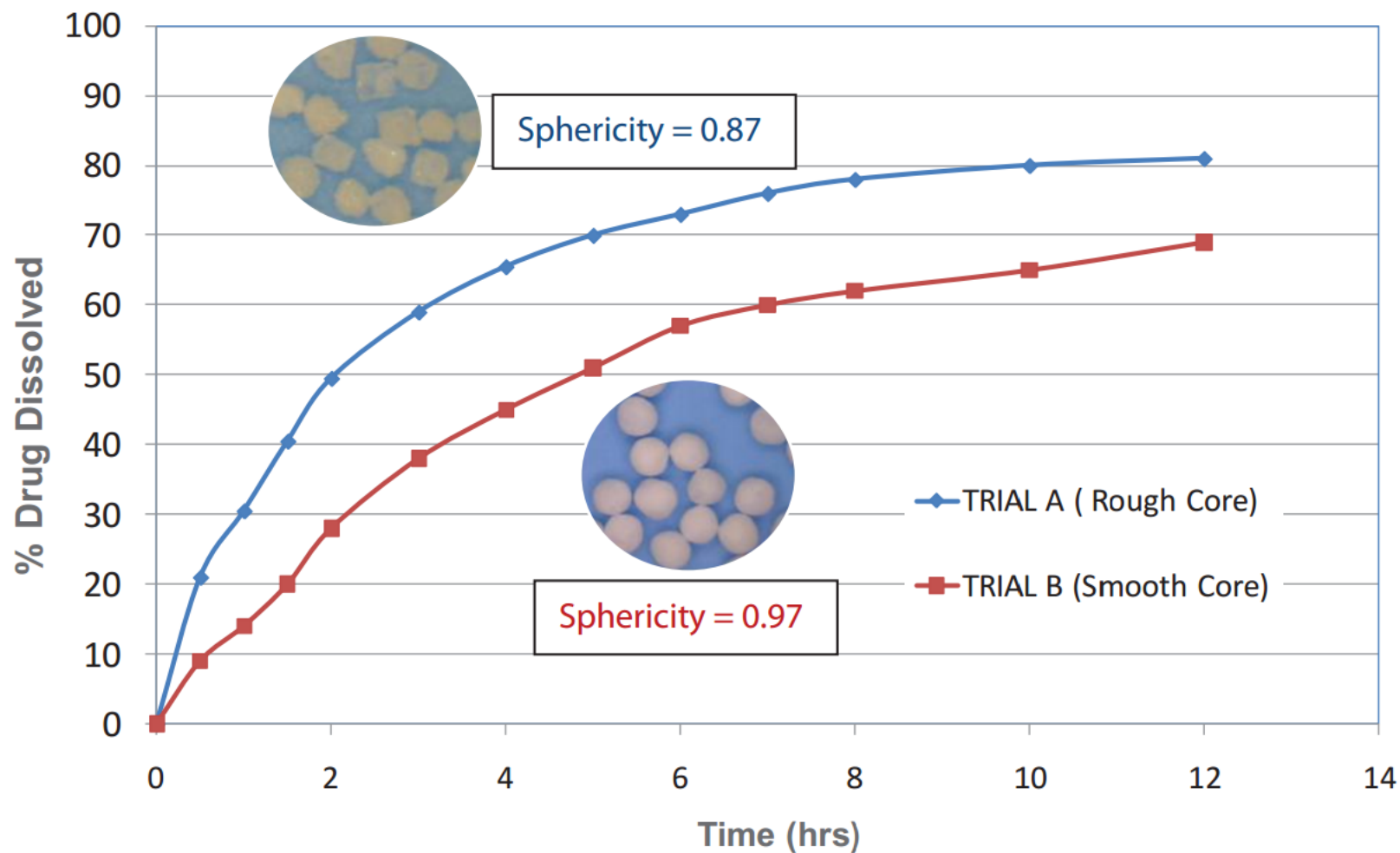
Effect of Shape on Flow

- Yes, I assumed density doesn't matter.
- Roundness is a measure based on particle perimeter.



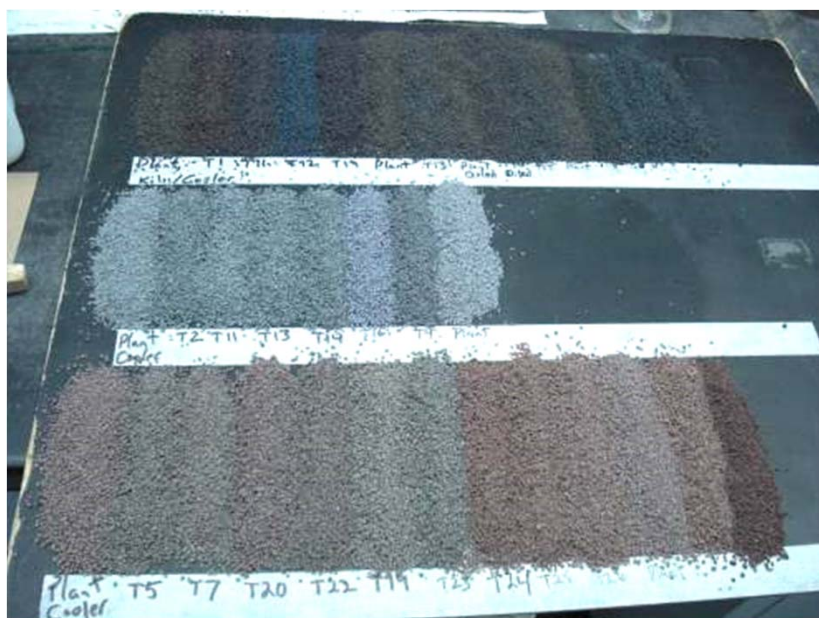
Why image analysis?

Shape affects drug release profile



Why image analysis?

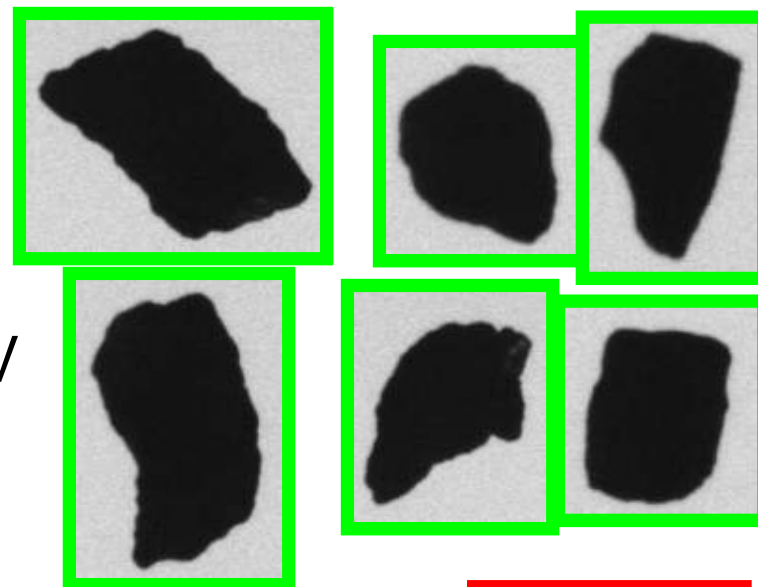
Shape is important for roofing granules that block sunlight from reaching next layer.



Why image analysis?

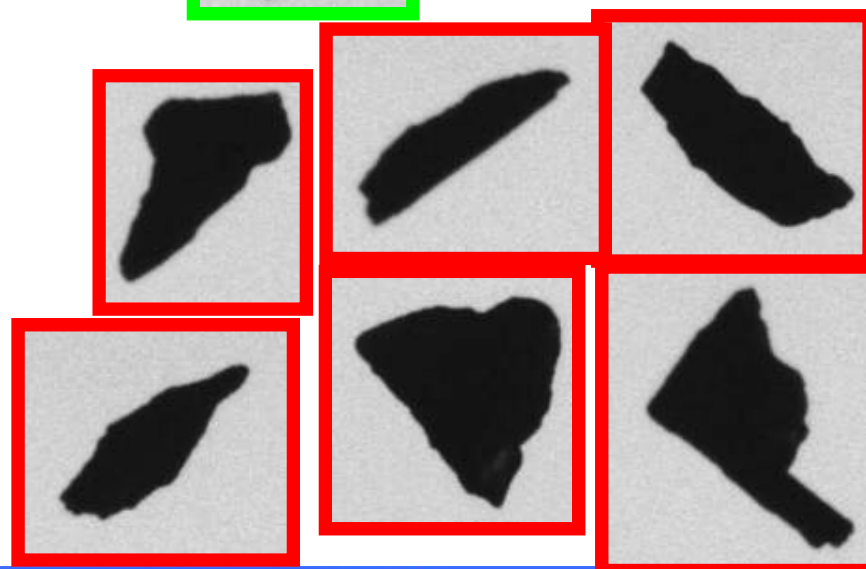
Good Product

Compact particles that fully block UV



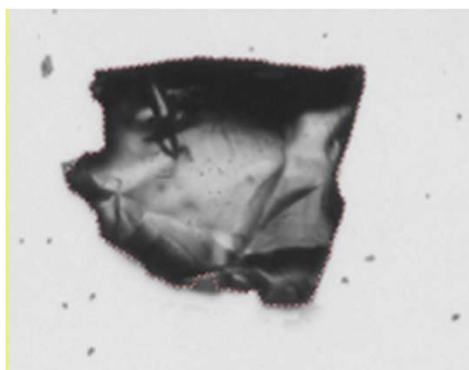
BAD Product

Flaky, angular, leaves gaps for UV to pass



Why image analysis

- Pictures: contaminants, identification, degree of agglomeration
- Screen excipients, full morphology
- Root cause of error (tablet batches), combined w/other techniques
- Replace manual microscopy



Major Steps in Image Analysis

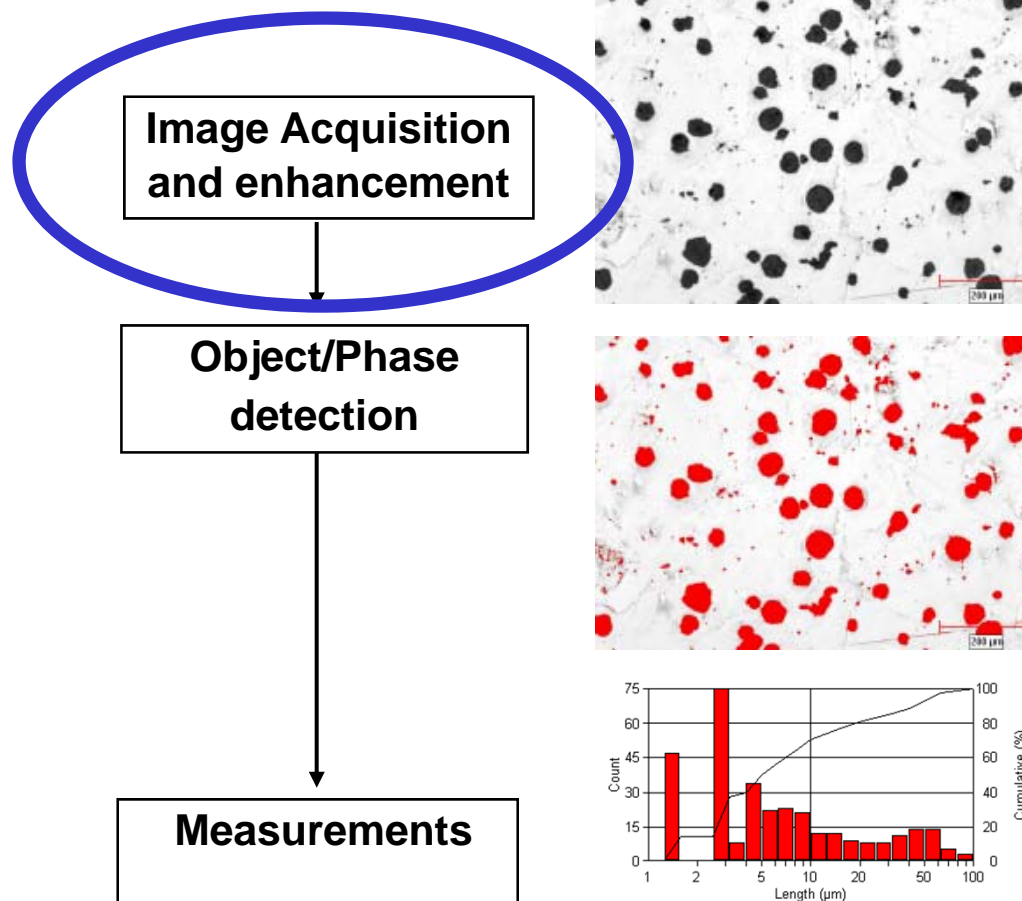
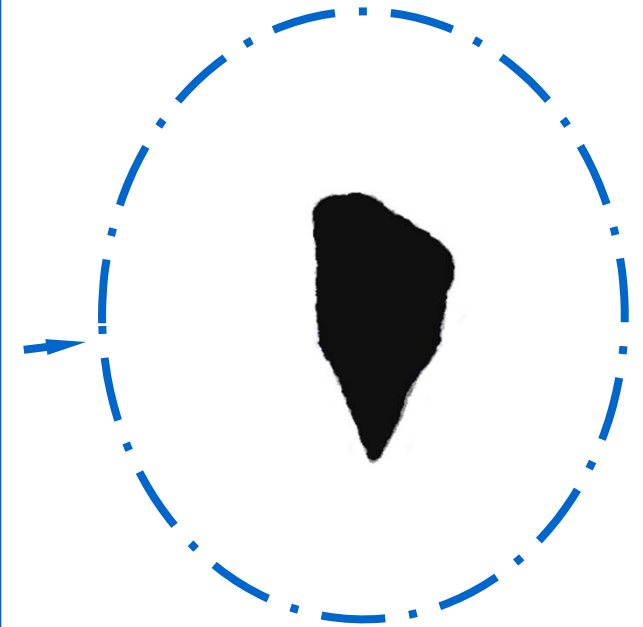
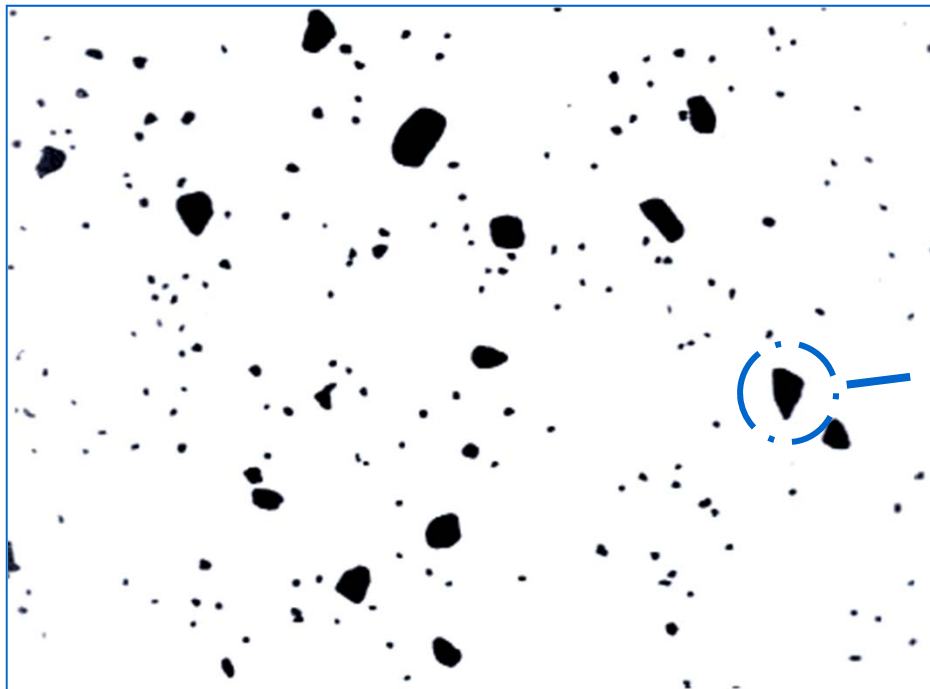


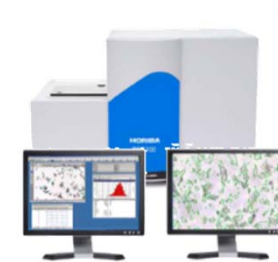
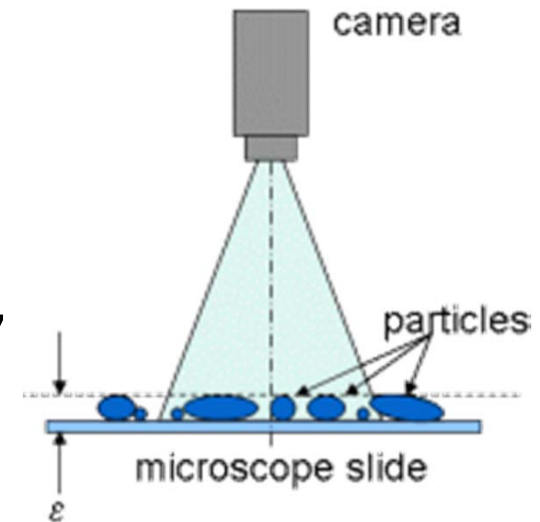
Image Analysis



Take a picture,
analyze for size

Static Image Analysis

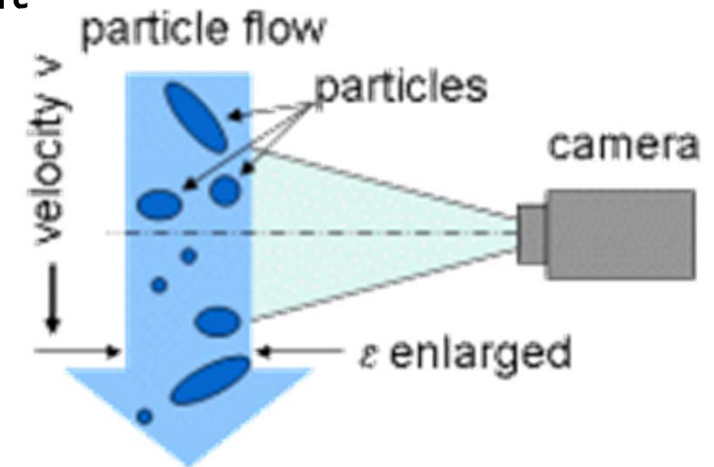
- Particles are dispersed (isolated) on a surface
- Picture are taken from stationary particles
- Camera or surface with particles is shifted, multiple images are taken from different positions, images are processed and evaluated
- High resolution images is possible
- Number of images/particles is limited (because of time limitations)
- Preferred orientation of the particles on the surface (largest 2D)



HORIBA PSA300

Dynamic Image Analysis

- Particles flow through the measurement volume of the instrument and the field of view of the camera
- Particles are captured during movement, no other moving parts necessary
- Capturing of many particle images in a short time interval
- Limitations because of image rate of the camera(s)
- Image quality is (a bit) worse
- Particles are projected in random orientation (3D)

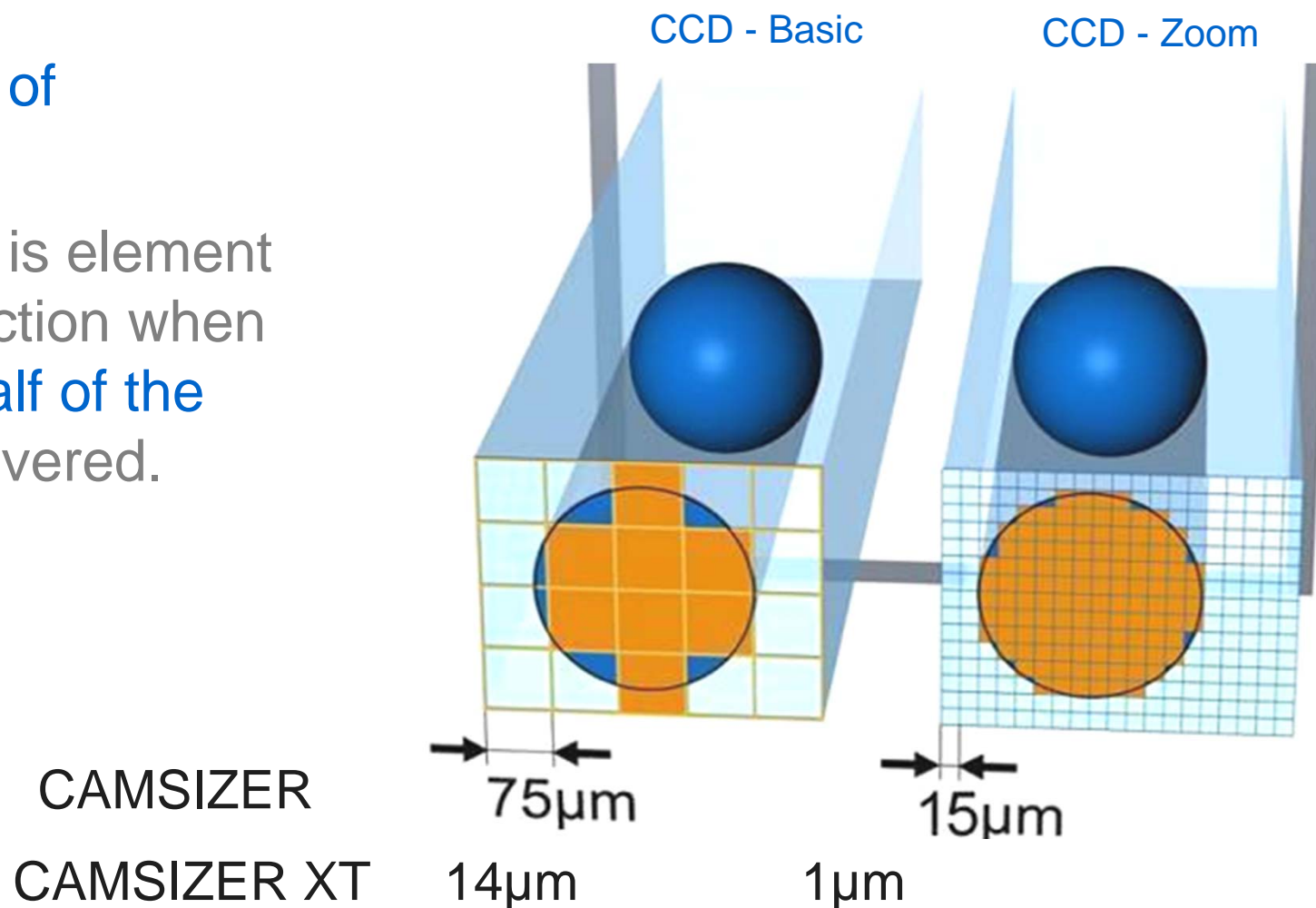


CAMSIZER

Resolution

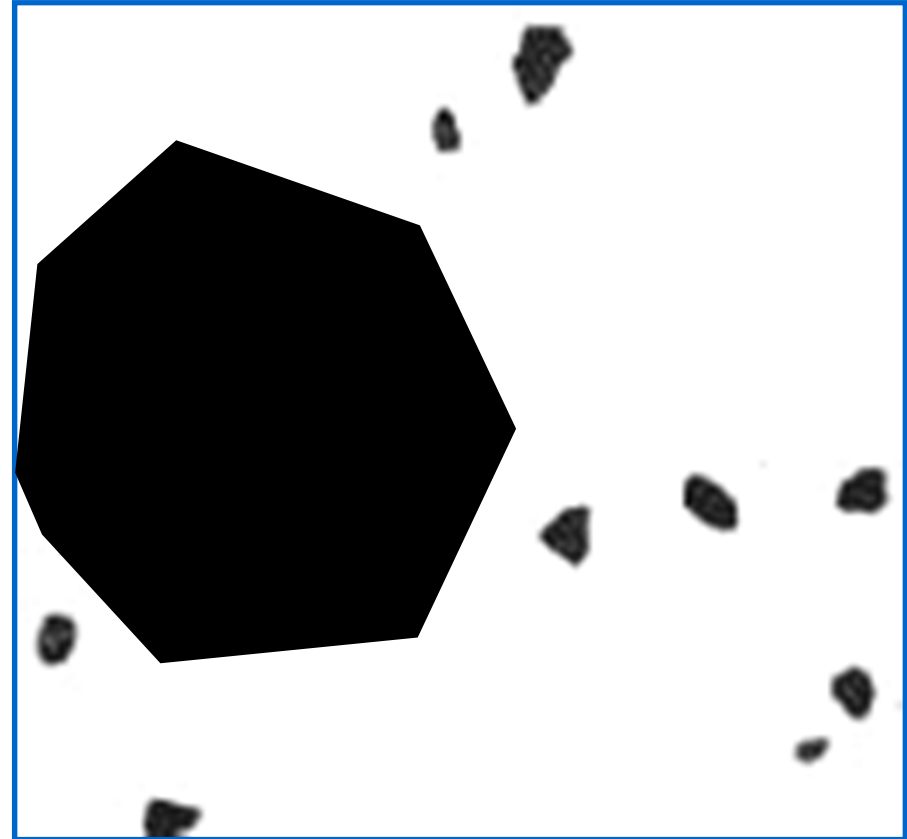
Detection of particles

One pixel is element of a projection when at least half of the pixel is covered.



Maximum size

**Large particles
cannot be
measured properly
even they fit in the
frame.**

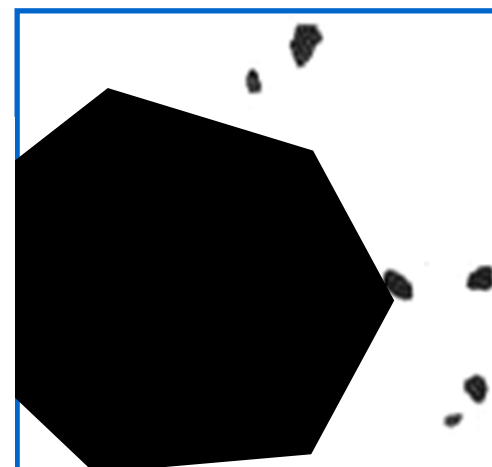
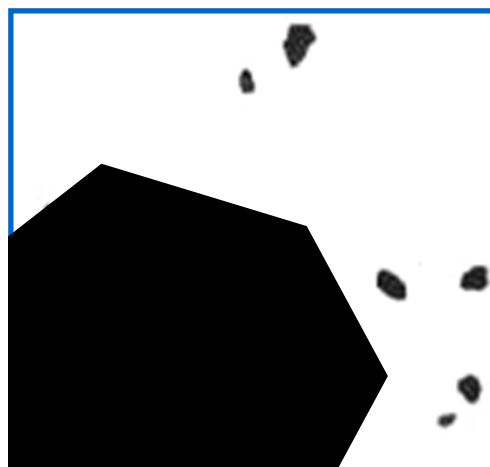
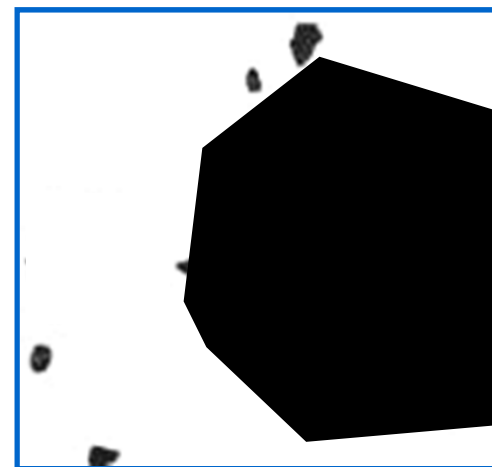
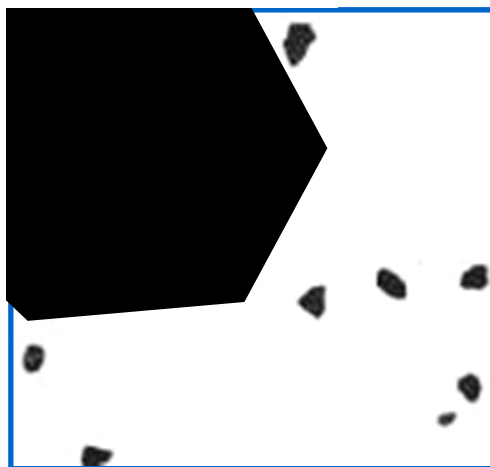


Maximum size

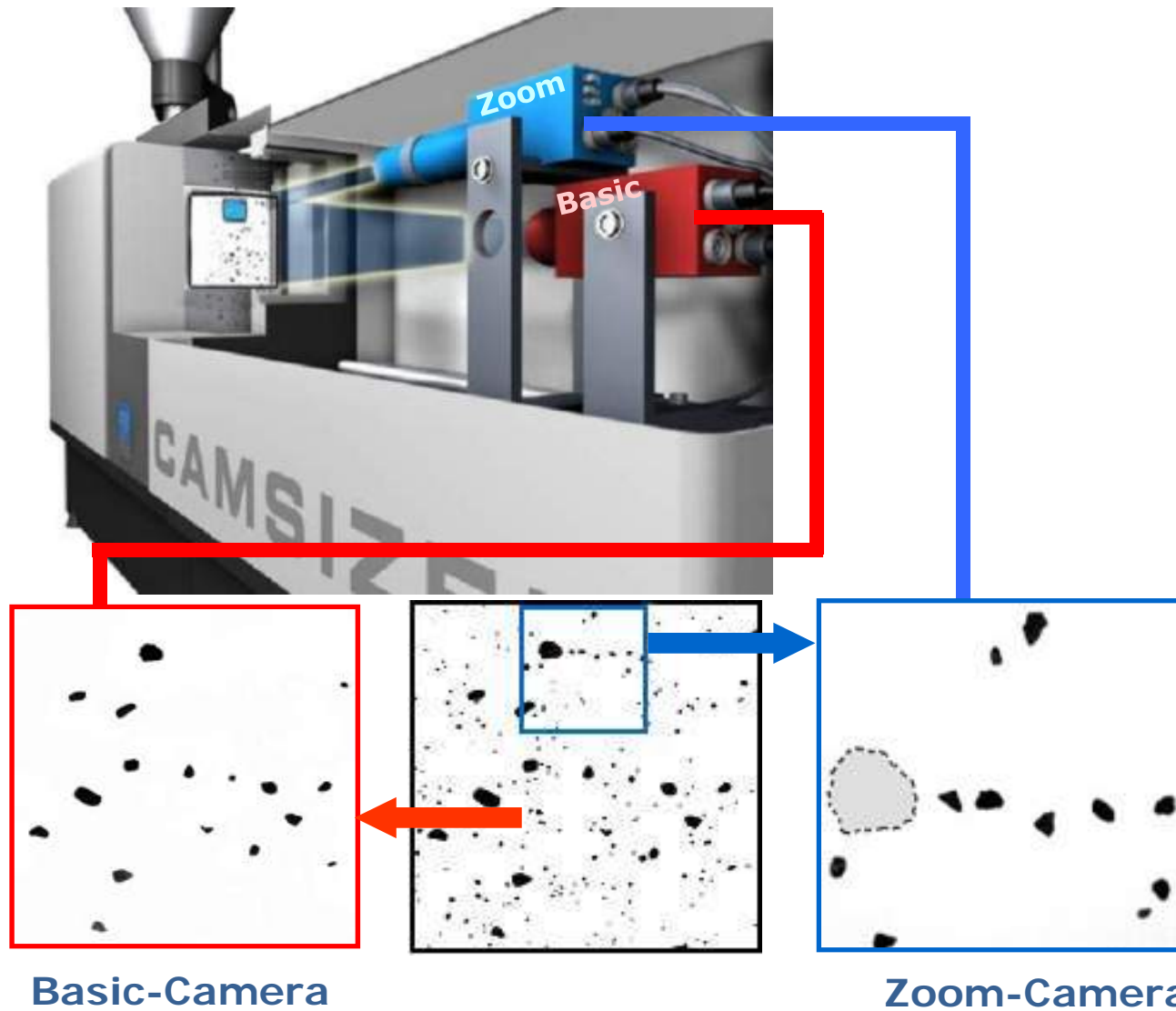
The probability of large particles touching the edge of the frame is higher than for smaller particles.

=> Large particles cannot be measured sufficiently

Upper limit of measurement range



Two-Camera-System

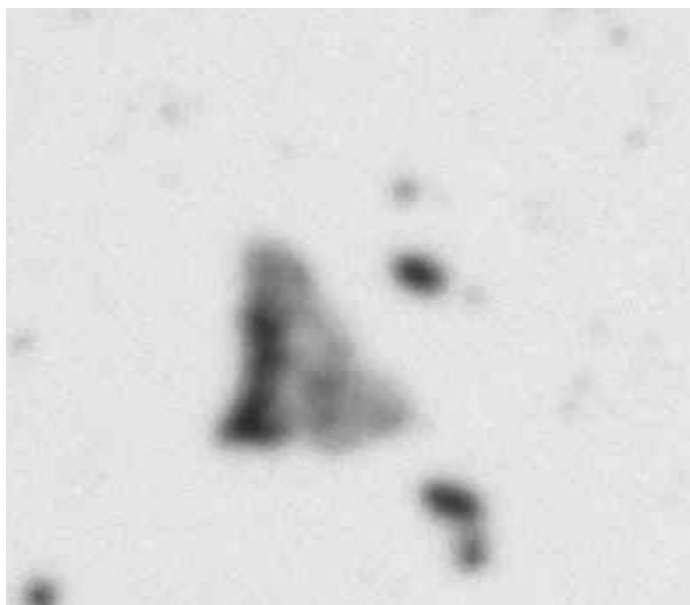


Acquiring Images

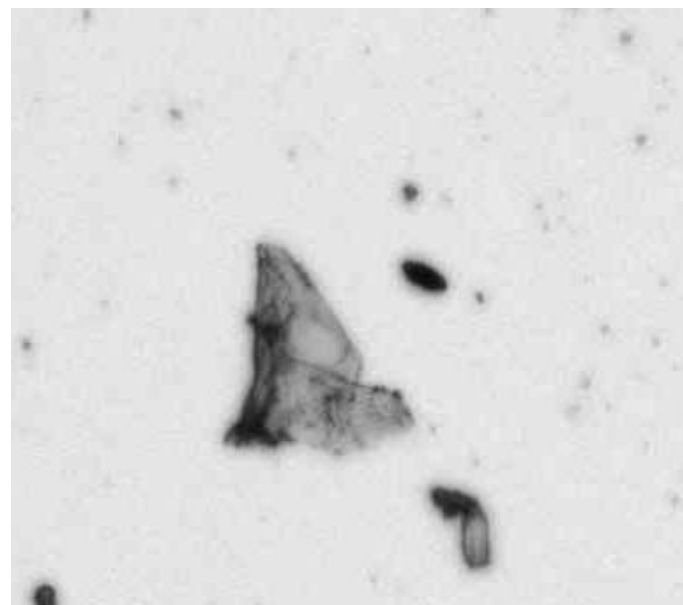
We want a good microscope and nice sharp images.

Pay attention to lighting and focus.

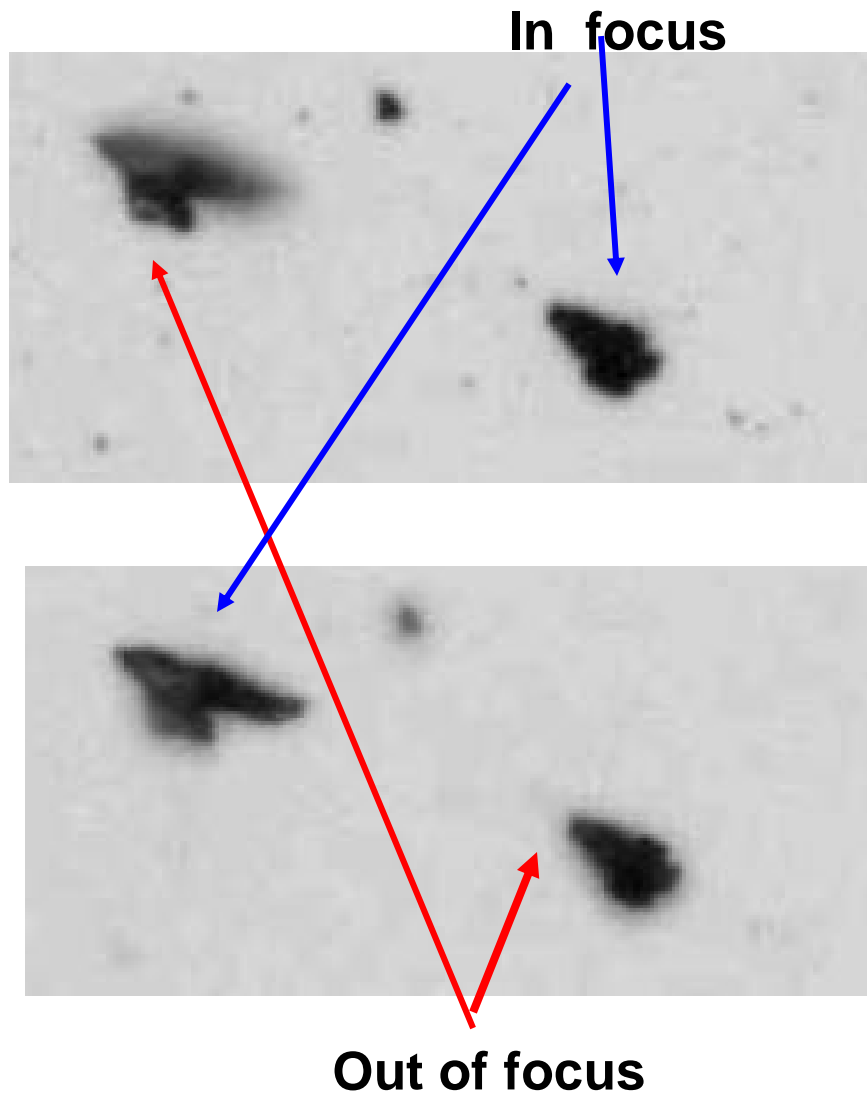
No



Yes



Multilayer Grab for Sharpness

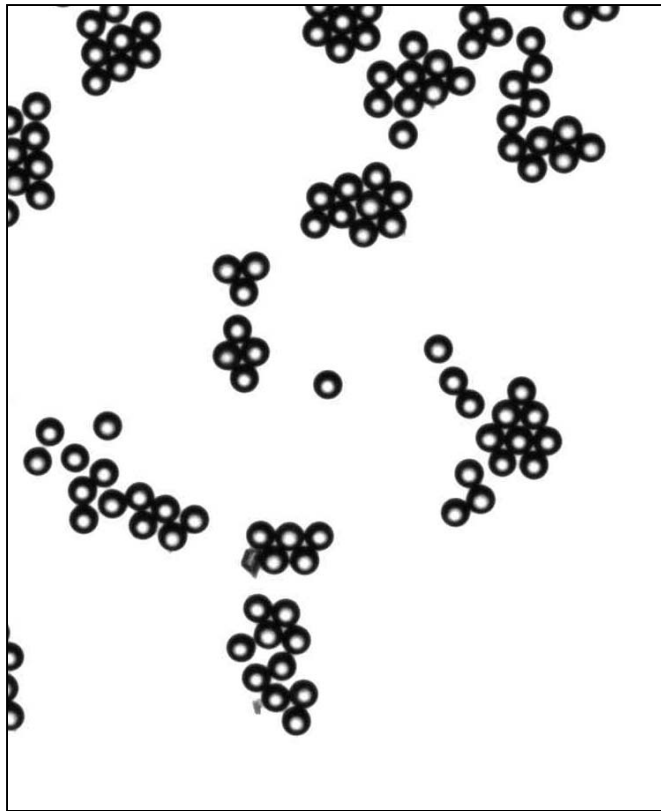


**Stack images for sharper
final image**

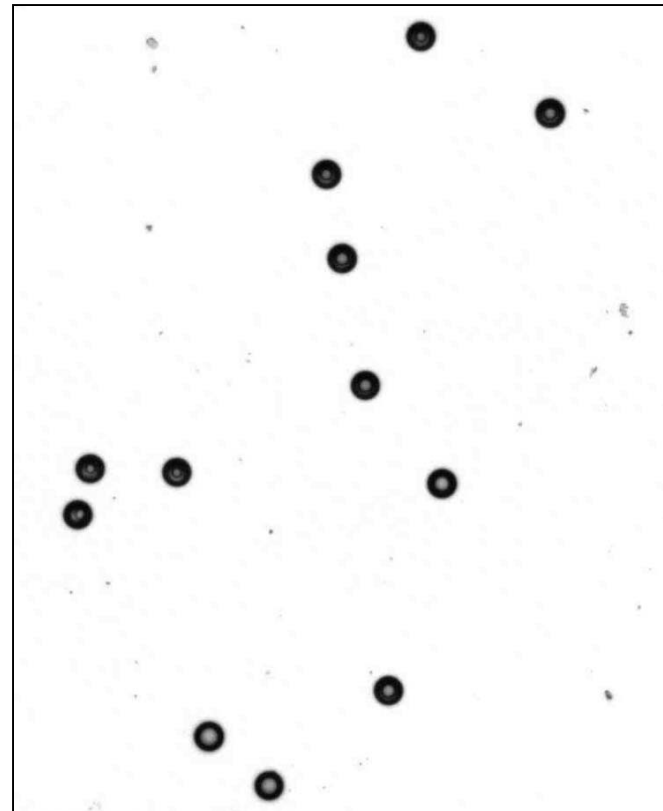
Dispersing a Sample

Want to spread particles out so that they don't touch.

No



Yes

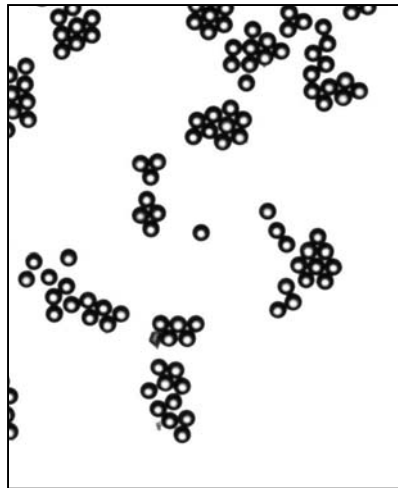


Control feed rate.

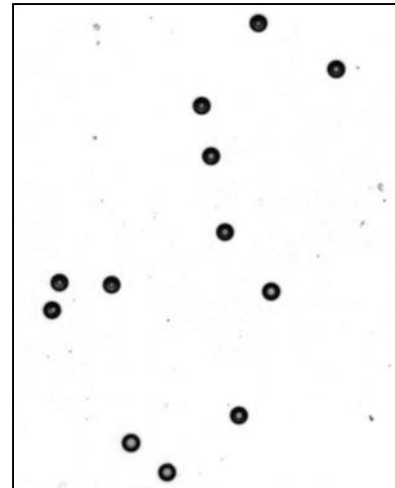
Want to spread particles out so that they don't touch.

Use % of field of view that is covered in order to control feed rate. Try 1% at first.

Feeding Too fast



Good



Major Steps in Image Analysis

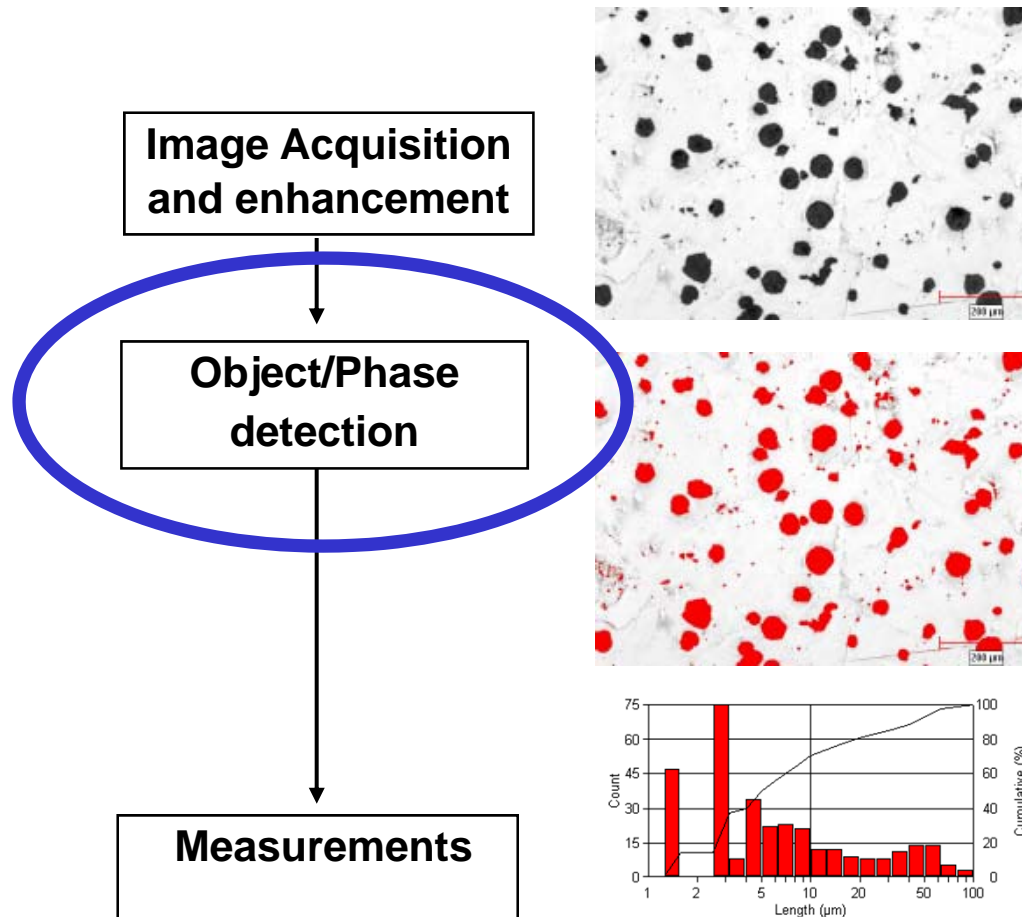
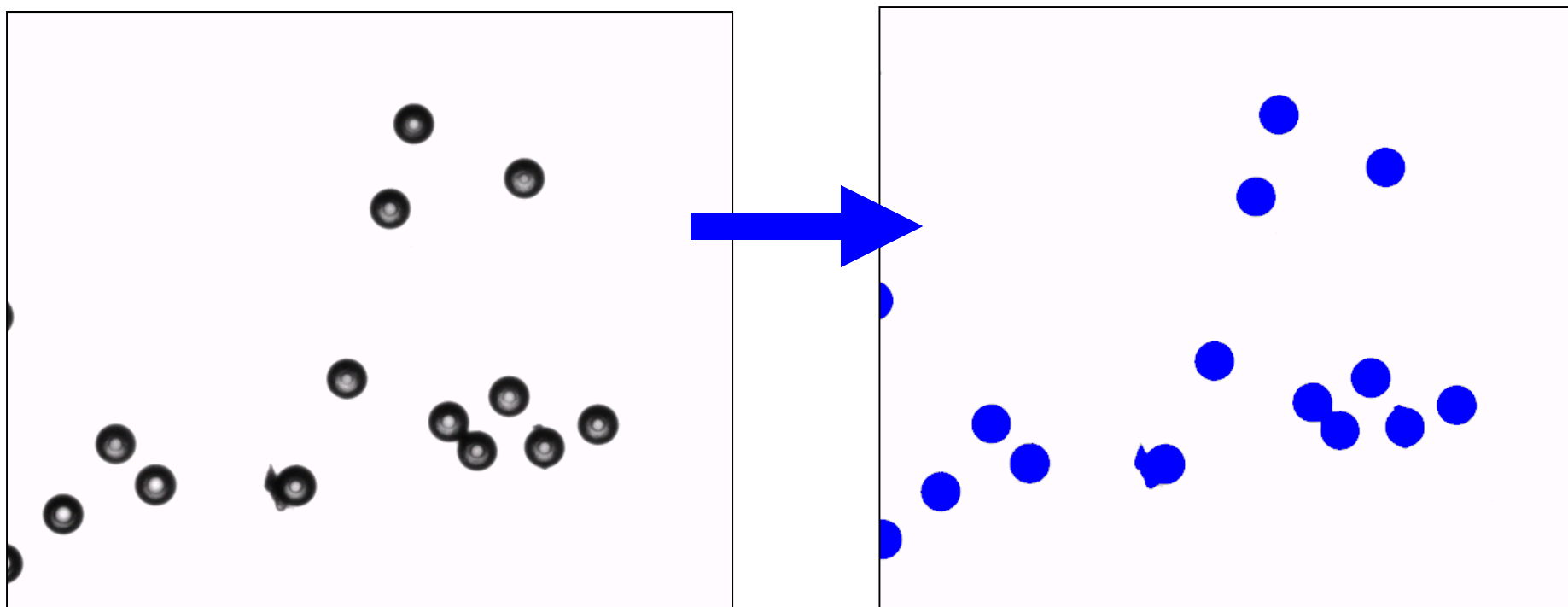
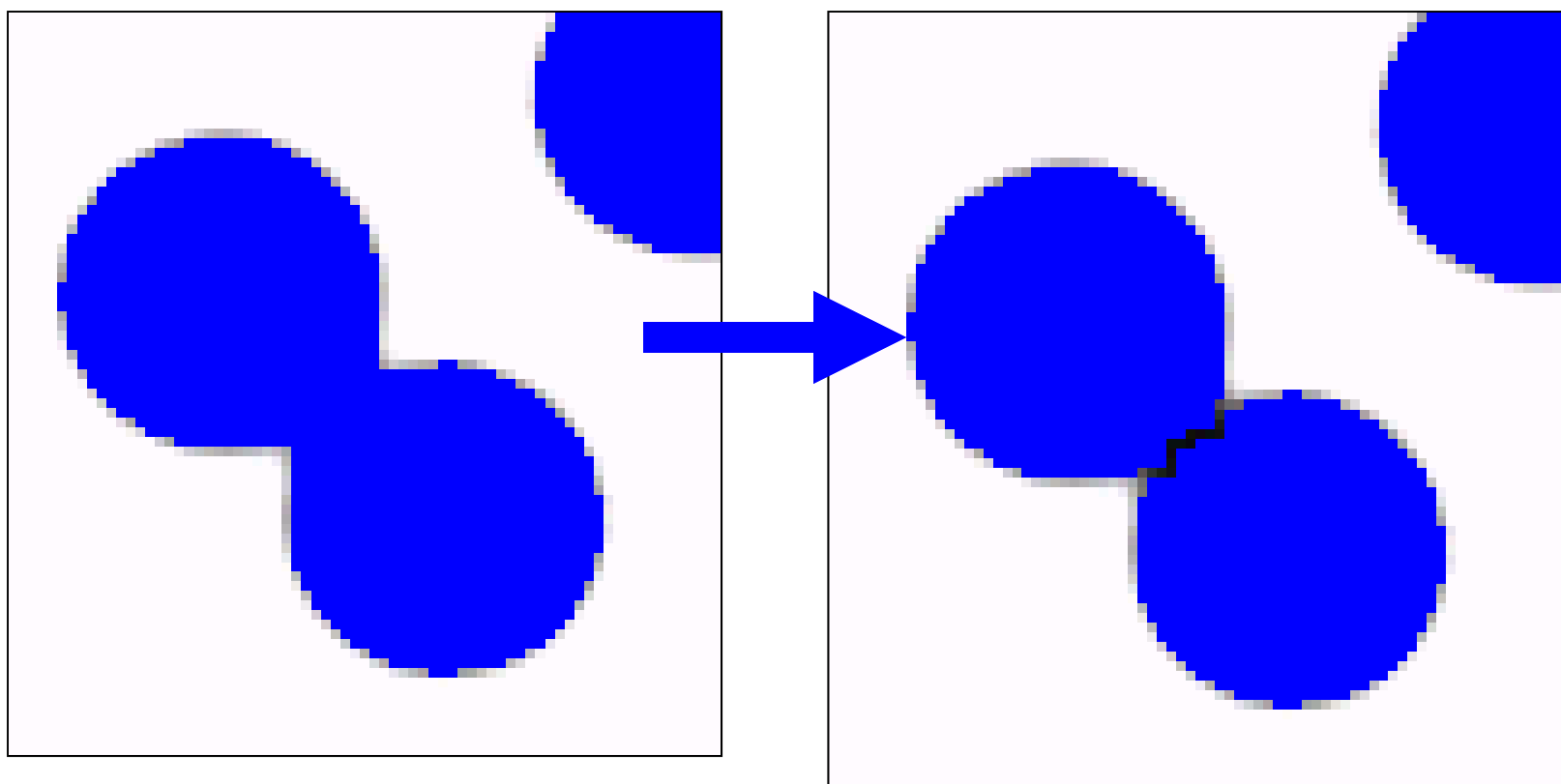


Image Binarization

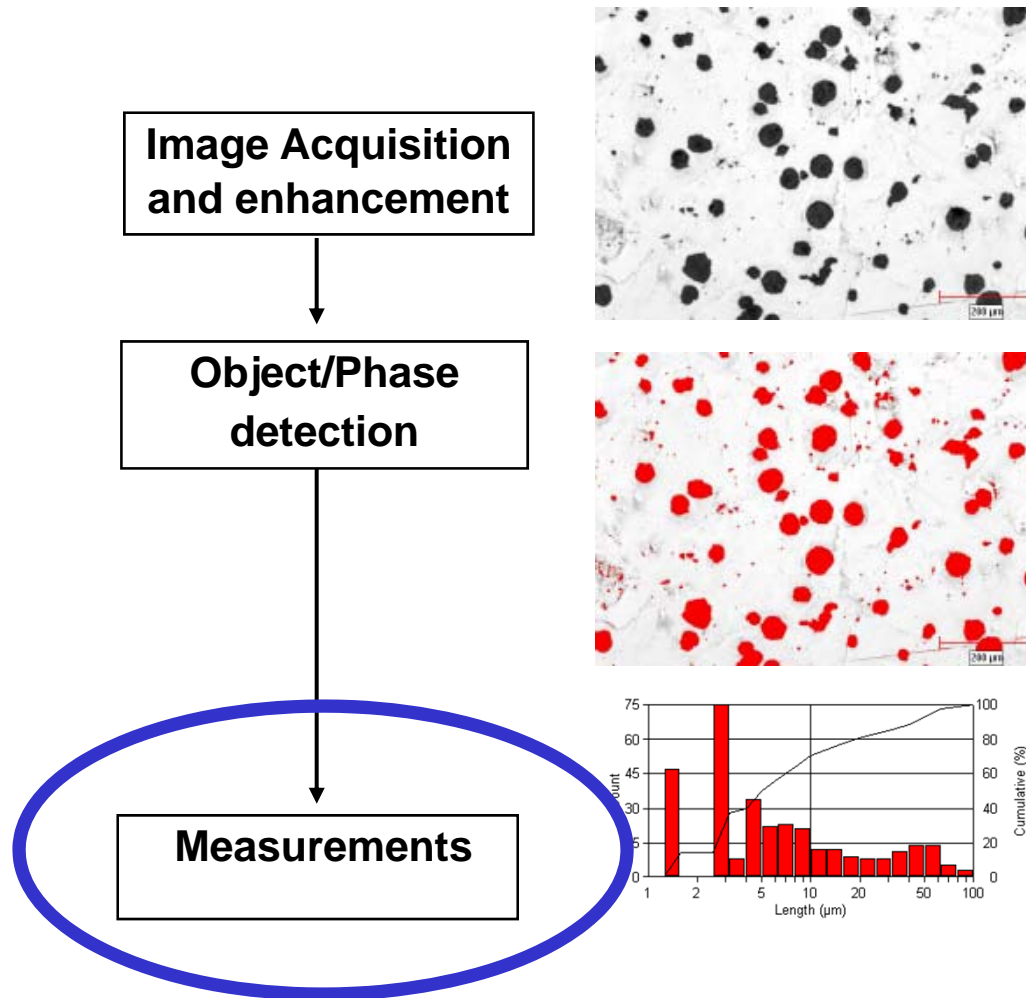
Turn into binary image (i.e., decide what is a particle and what isn't).



Separation

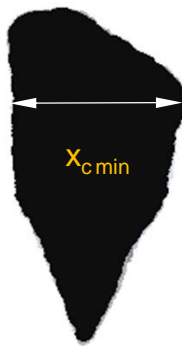


Major Steps in Image Analysis



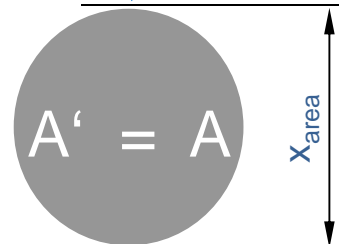
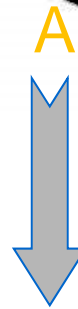
Many Size Measures

X_{cmin}
“width”

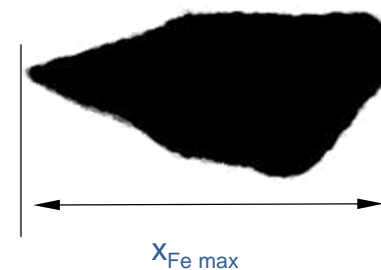


Width is best
suited for
comparison with
sieves !

X_{area}
“diameter over
projection surface”



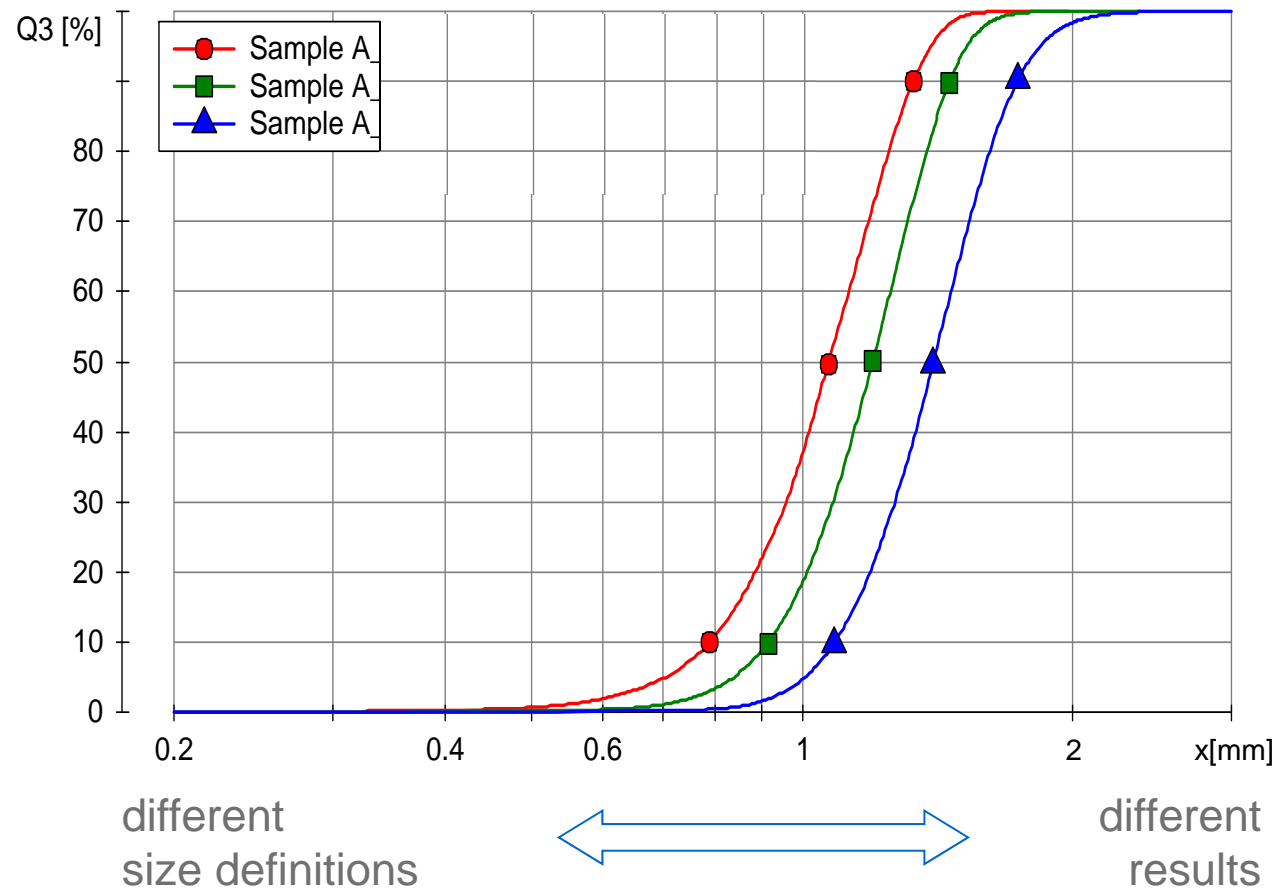
X_{Femax}
“length”



Shape parameters
can be calculated!

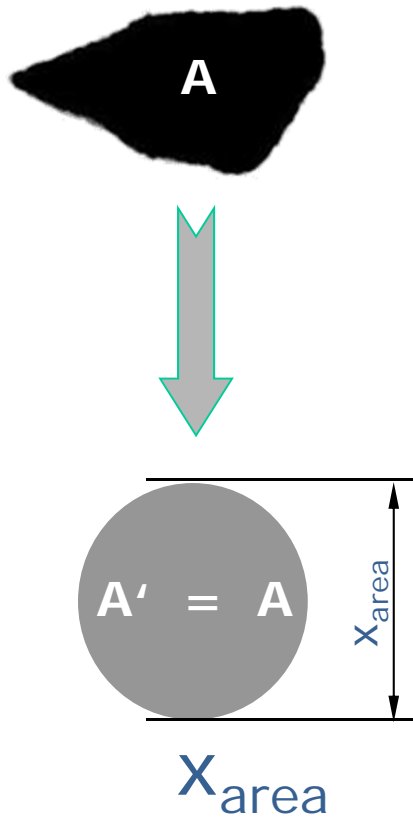
Comparison of Size Definitions

X_{Cmin} \Leftrightarrow X_{Area} \Leftrightarrow X_{Femax}

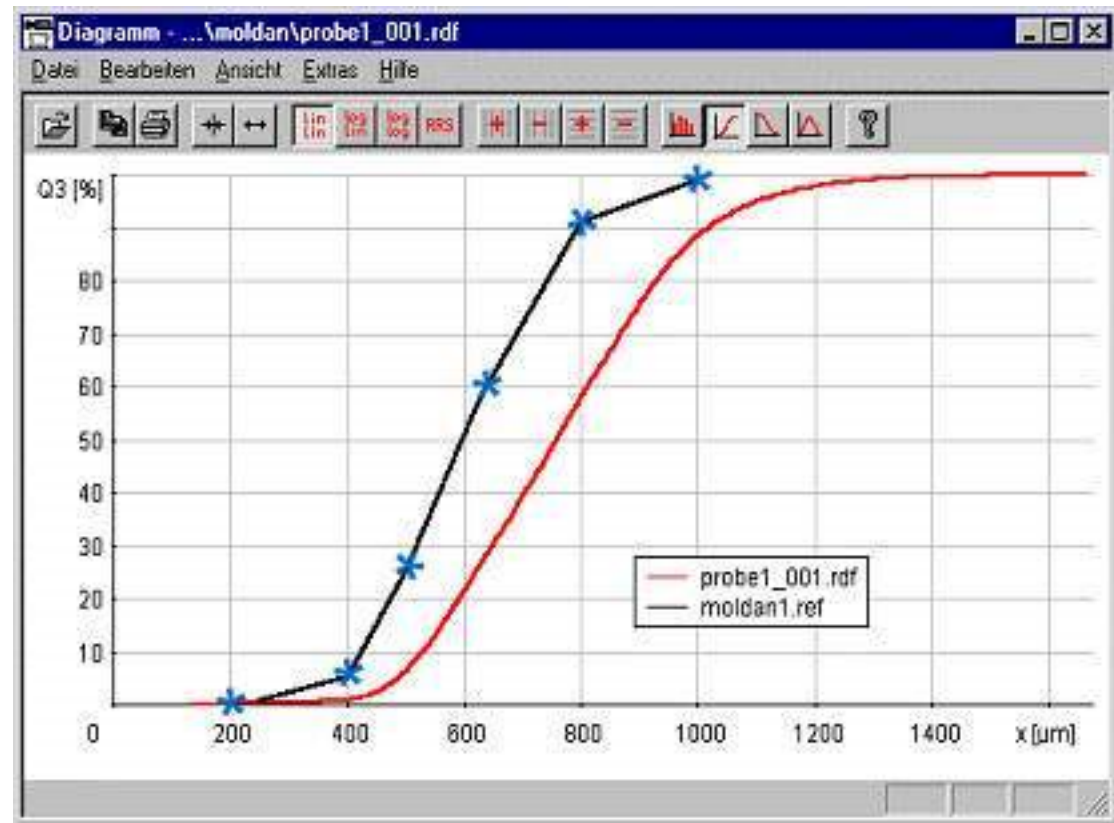


Digital Image Processing

Area Measurement \Leftrightarrow Sieving



"diameter
via projection surface"



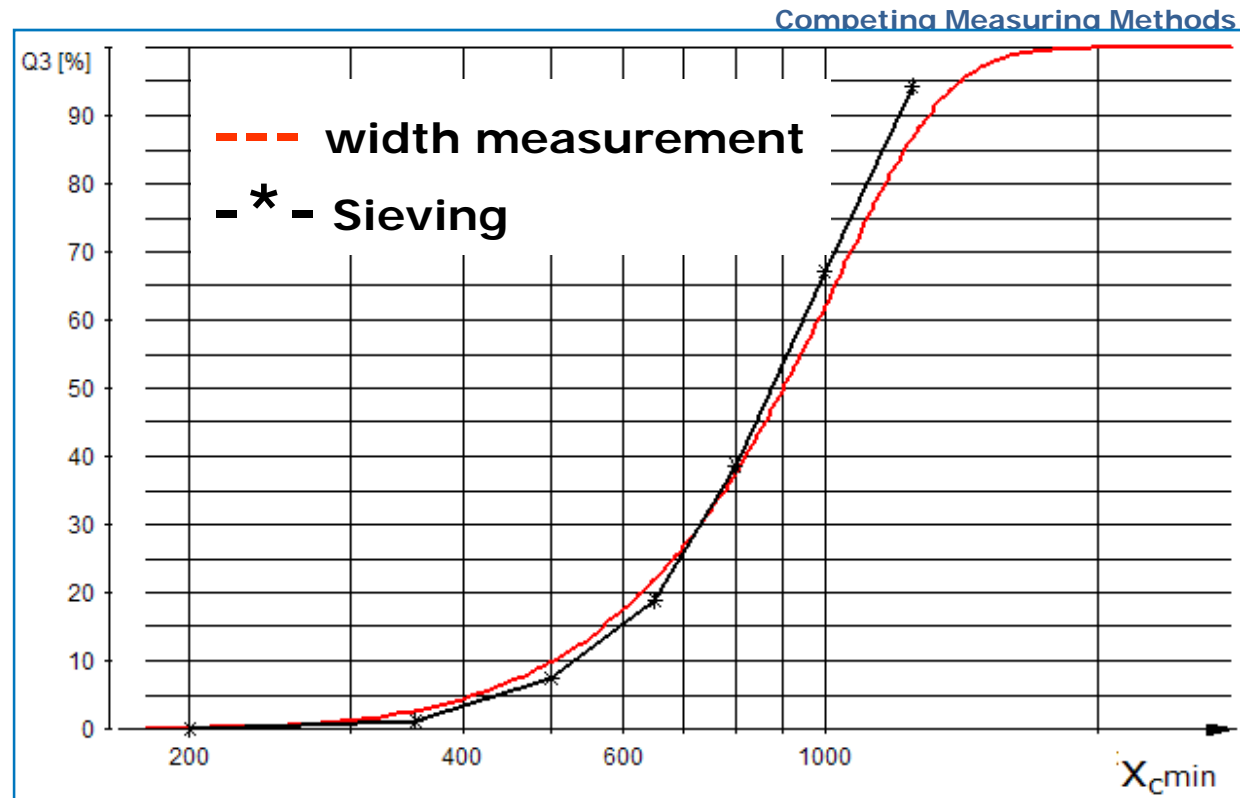
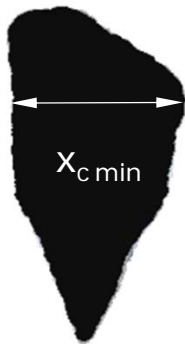
comparison

CAMSIZER-measurement **x_{area}** (**red**)
and sieving * (**blue**)

Digital Image Processing

Measuring of Width \leftrightarrow Sieving

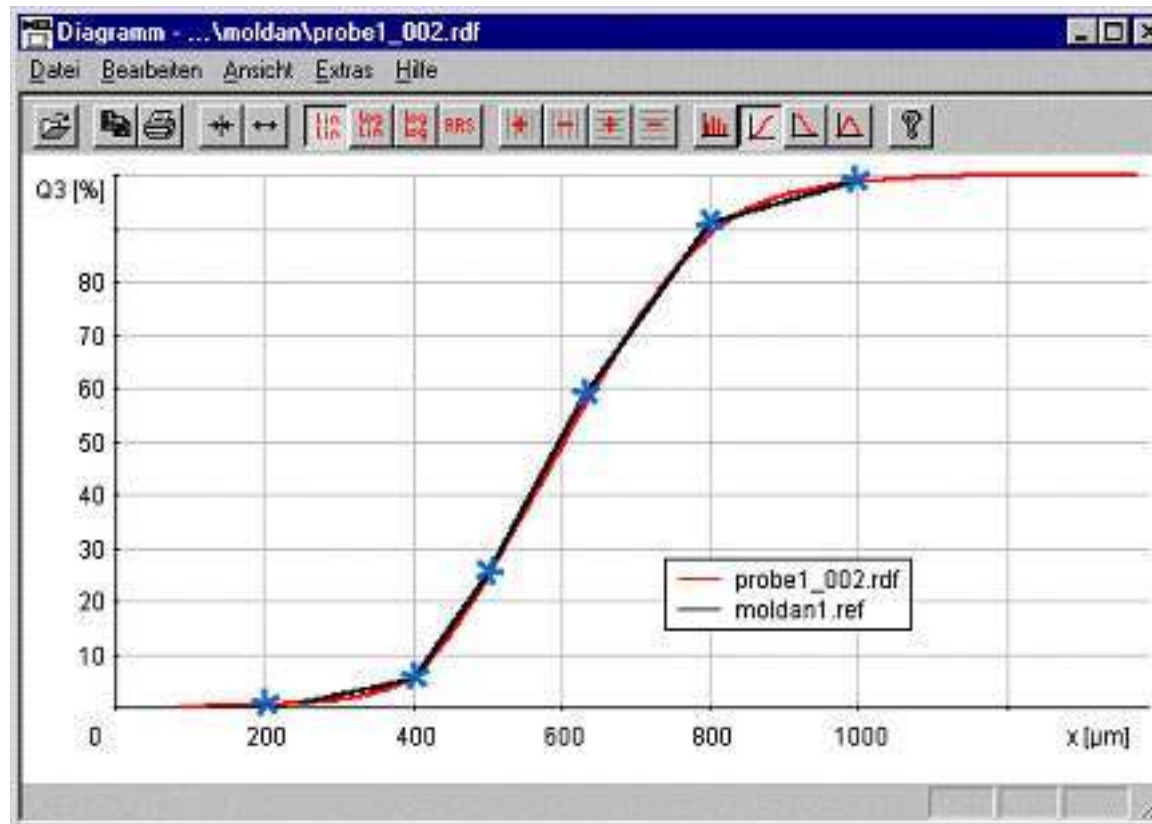
$X_{c\ min}$
"width"



comparison

CAMSIZER-measurement $X_{c\ min}$ (red)
and sieving * (black)

Fitting of CAMSIZER results to Sieving



fitted result

CAMSIZER-measurement x_{area} (red)
to sieving * (blue)

Shape: Aspect Ratio

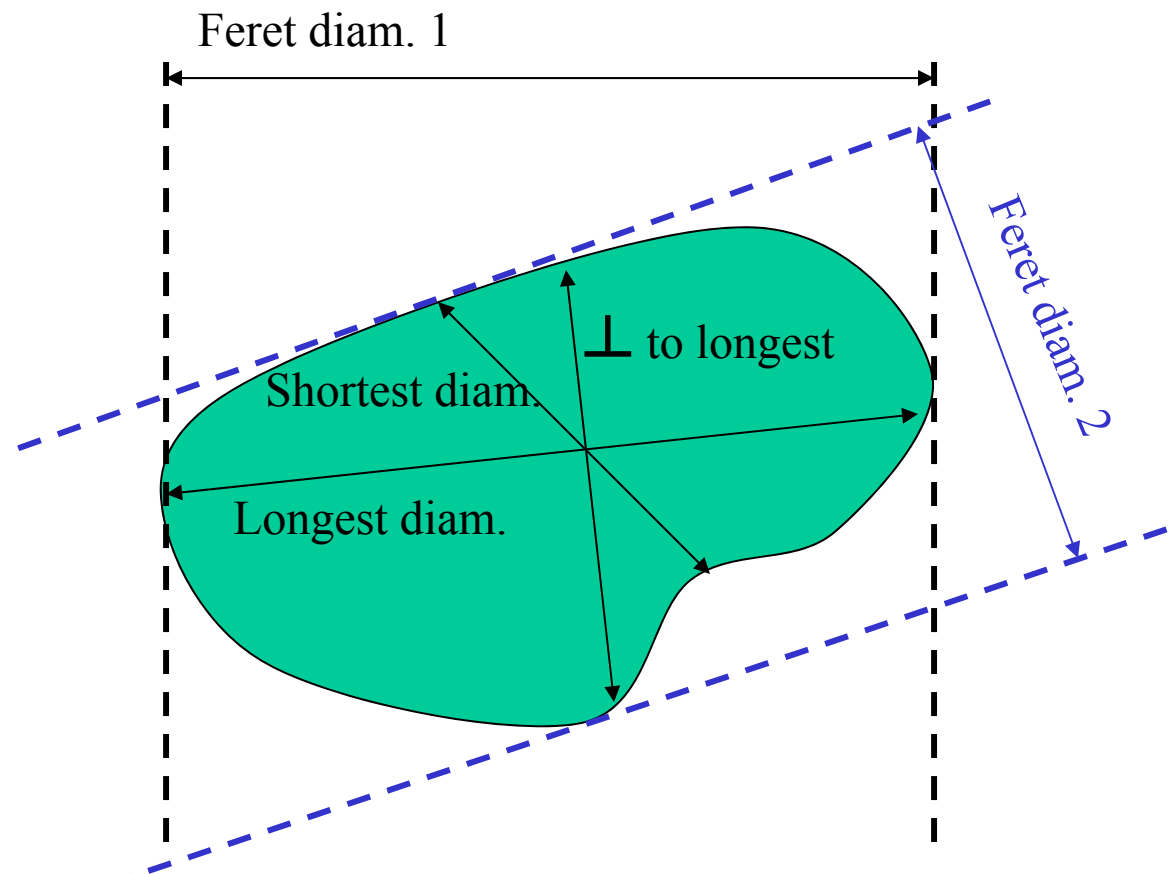
Aspect ratio

= $\frac{\text{shortest diam}}{\text{longest diam}}$

= $\frac{\perp \text{ to longest diam}}{\text{longest diam}}$

= $\frac{\text{shortest Feret diam}}{\text{longest Feret diam}}$

= three different numbers!



More Shape Descriptors

Roundness

A shape measure that quantifies the "roundness" of an object's edges:

$$\frac{4 \times \text{Area}}{(\pi \times L \times L)}$$

Roughness

A shape measure that quantifies the jaggedness of an object's edges:

$$\frac{\text{Convex perimeter}}{\text{Perimeter}}$$

Aspect Ratio

Ratio of length over width.

$$\frac{\text{Length of longest feret}}{\text{Length of shortest feret}} = \frac{\text{Length}}{\text{Width}}$$

Compactness

Ratio of area over convex perimeter:

$$\frac{4\pi A}{\text{Convex perimeter}^2}$$

Fractal Dimension

Numerical characterization of irregular contours through fractal geometry.

$$P = P_\epsilon \delta^{1-D}$$

D is the Fractal Dimension, d is the unit length of the scale used for the measurement and P is the perimeter of the object ($1 < D < 2$).

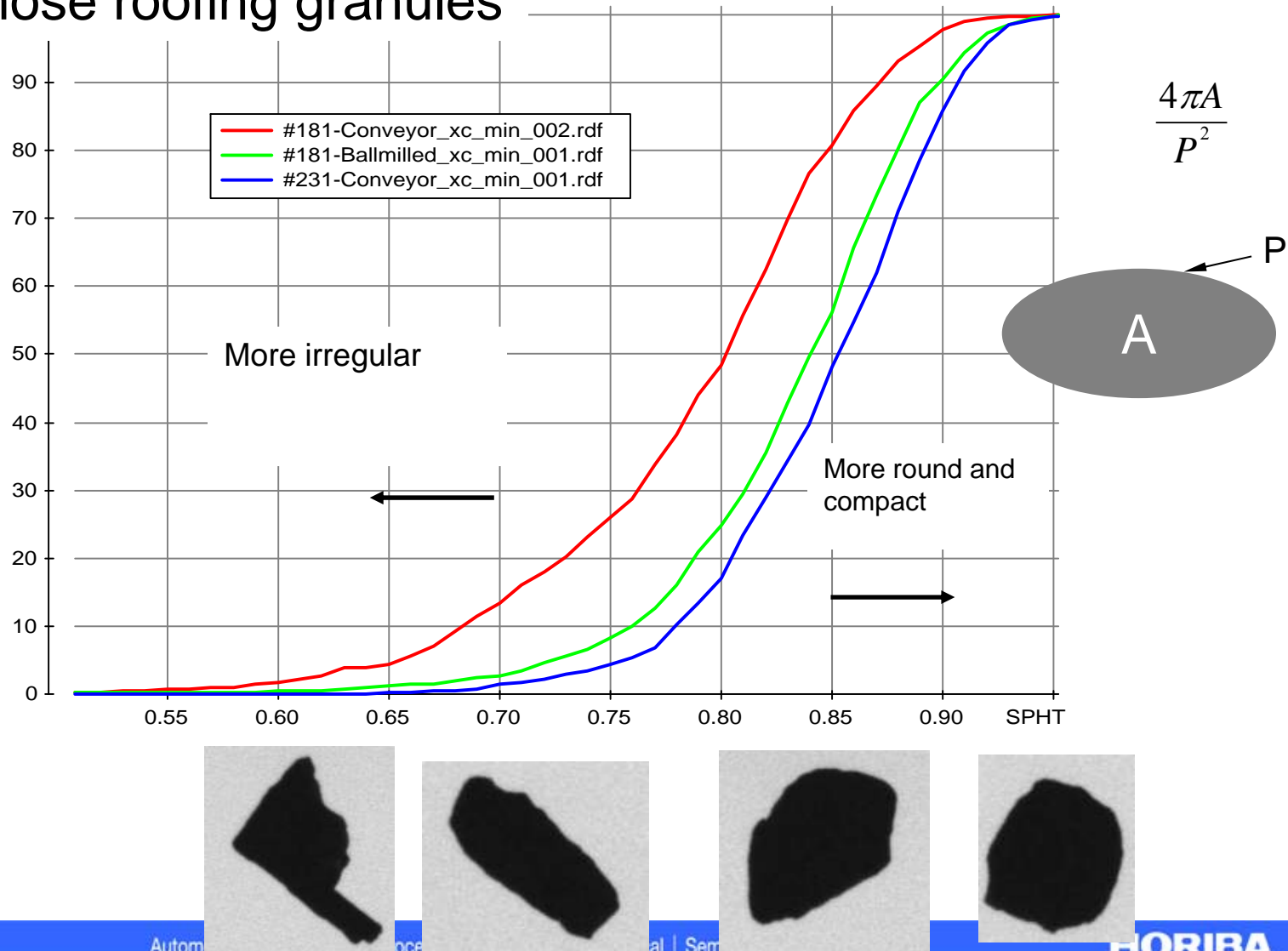
Sphericity

Estimate of the sphericity of an object:

$$\frac{4\pi A}{P^2}$$

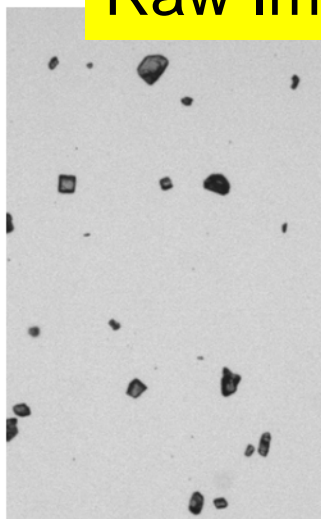
Shape analysis

Back to those roofing granules



Data Evaluation

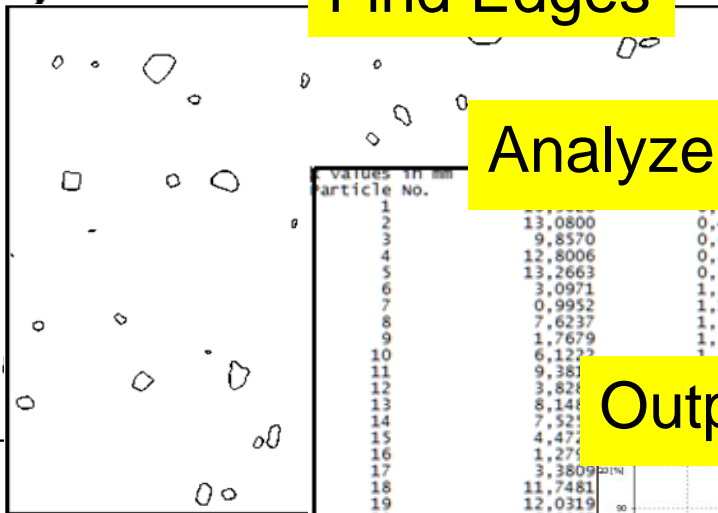
Raw Image



Binarize




Find Edges



Analyze Each Particle

Particle No.	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20	21						
Values in mm	13.0800	9.8570	12.8006	13.2663	3.0971	0.9952	7.6237	1.7679	6.1223	9.381	3.821	8.141	7.521	4.471	1.271	3.3809	11.7481	12.0319	5.8967	1.7070							
	0.4677	0.6081	0.8691	0.7529	1.2902	1.1762	1.2215	1.2251	1.5743	0.2176	0.4872	0.3937	0.2767	0.5874	0.2226	0.1609	0.1242	0.3363	0.2156	0.4746	0.3894	0.2720	0.5833	0.2194	0.1594	0.1238	0.3130

Output Distribution

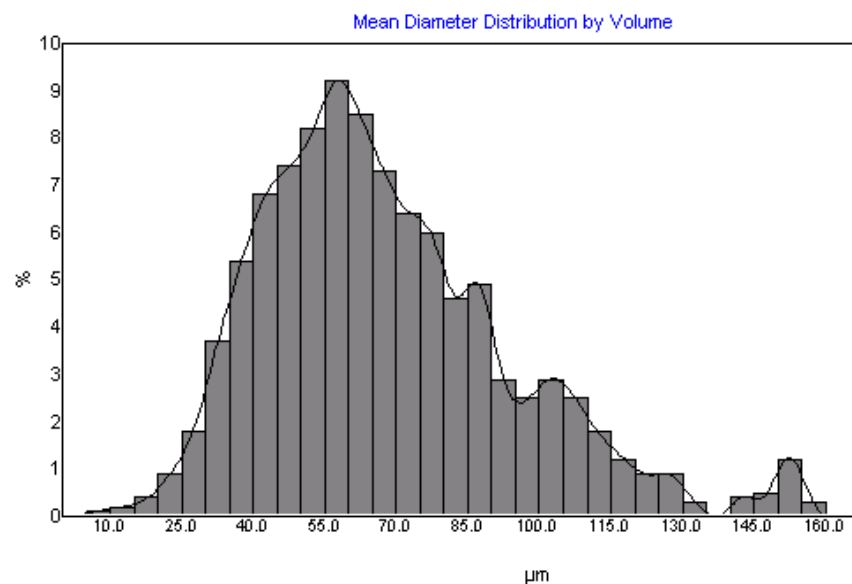


Output Distribution

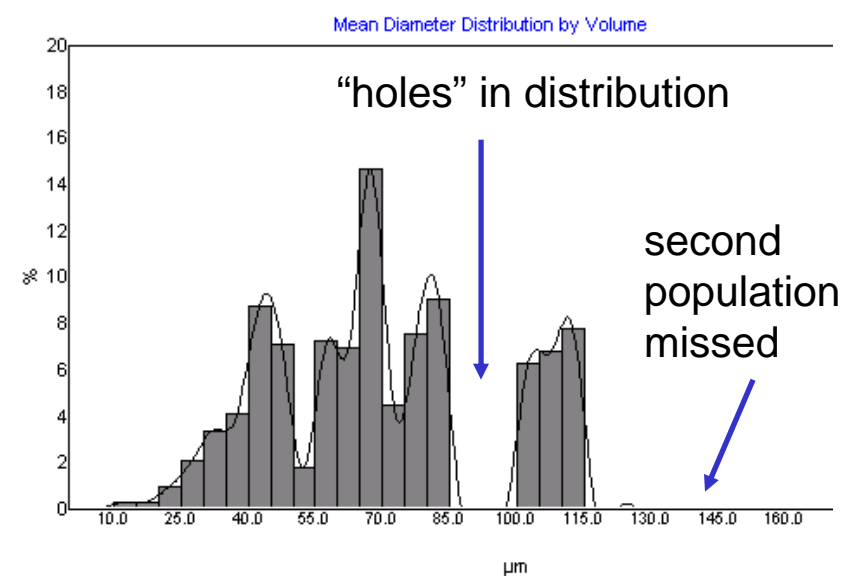


Effect of Number of Particles Counted

20,000 particles

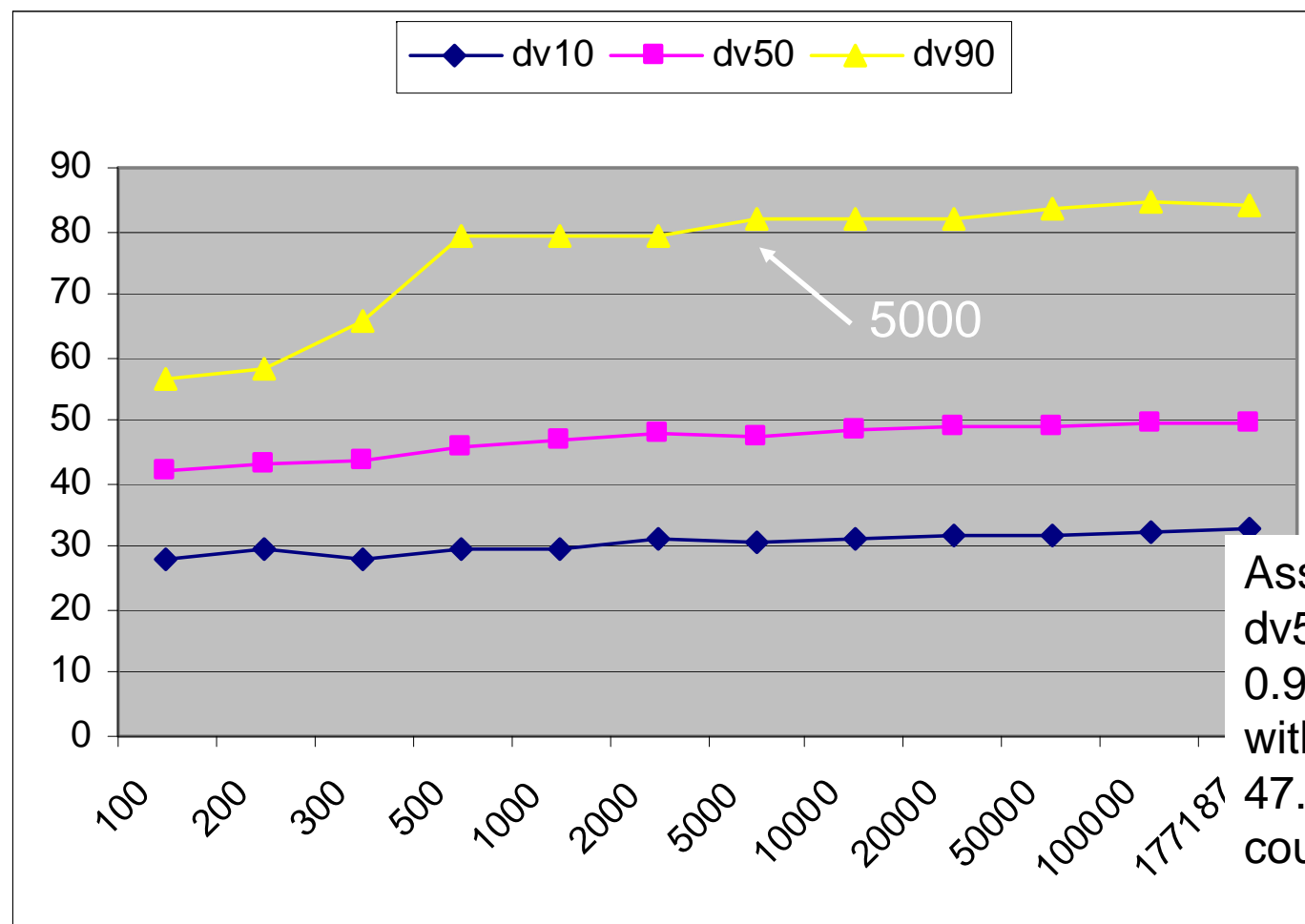


200 particles



But d10, d50 & d90 may appear similar

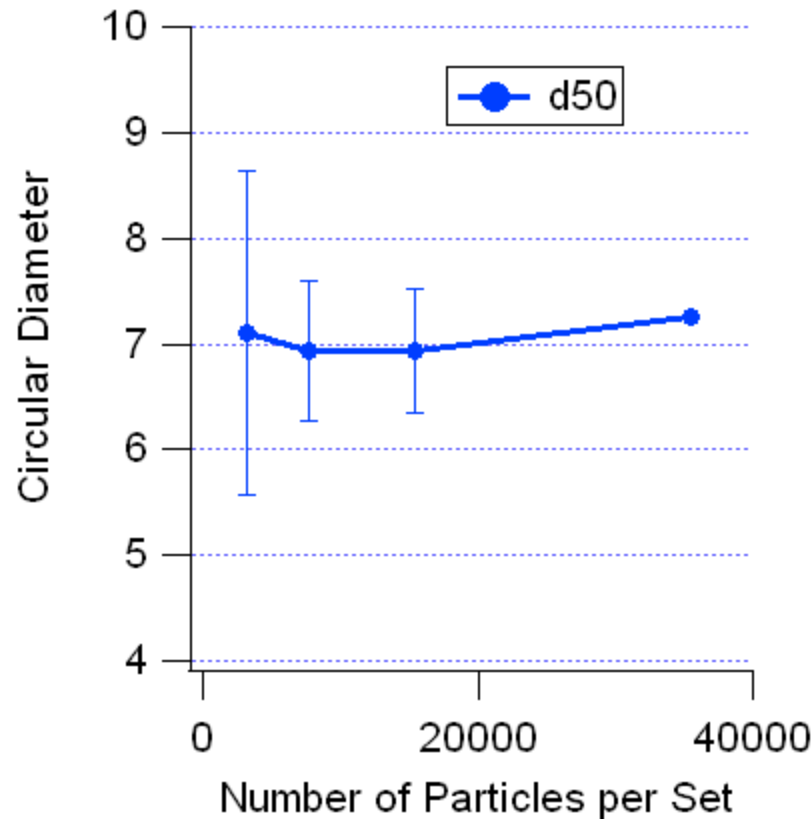
More particles for more accuracy.



Assume 49.833 is “correct”
dv50,
 $0.95 \times 49.833 = 47.34$ is
within 95%,
47.463 achieved by 5000
counts!

Use this to control precision of your data (and not spend extra time on precision you don't need.

Divide Large Data Set into Smaller Sets



- Error bars are one standard deviation from repeated measurements of the same number of particles from different parts of the sample.
- The error bars get smaller as you evaluate more particles.

<USP> 776: Standard Deviation

$$\sqrt{s^2 \left(\frac{n}{\chi_a^2} \right)} < \sigma < \sqrt{s^2 \left(\frac{n}{\chi_b^2} \right)}$$

χ =Moment of chi squared distribution (see a statistics book)

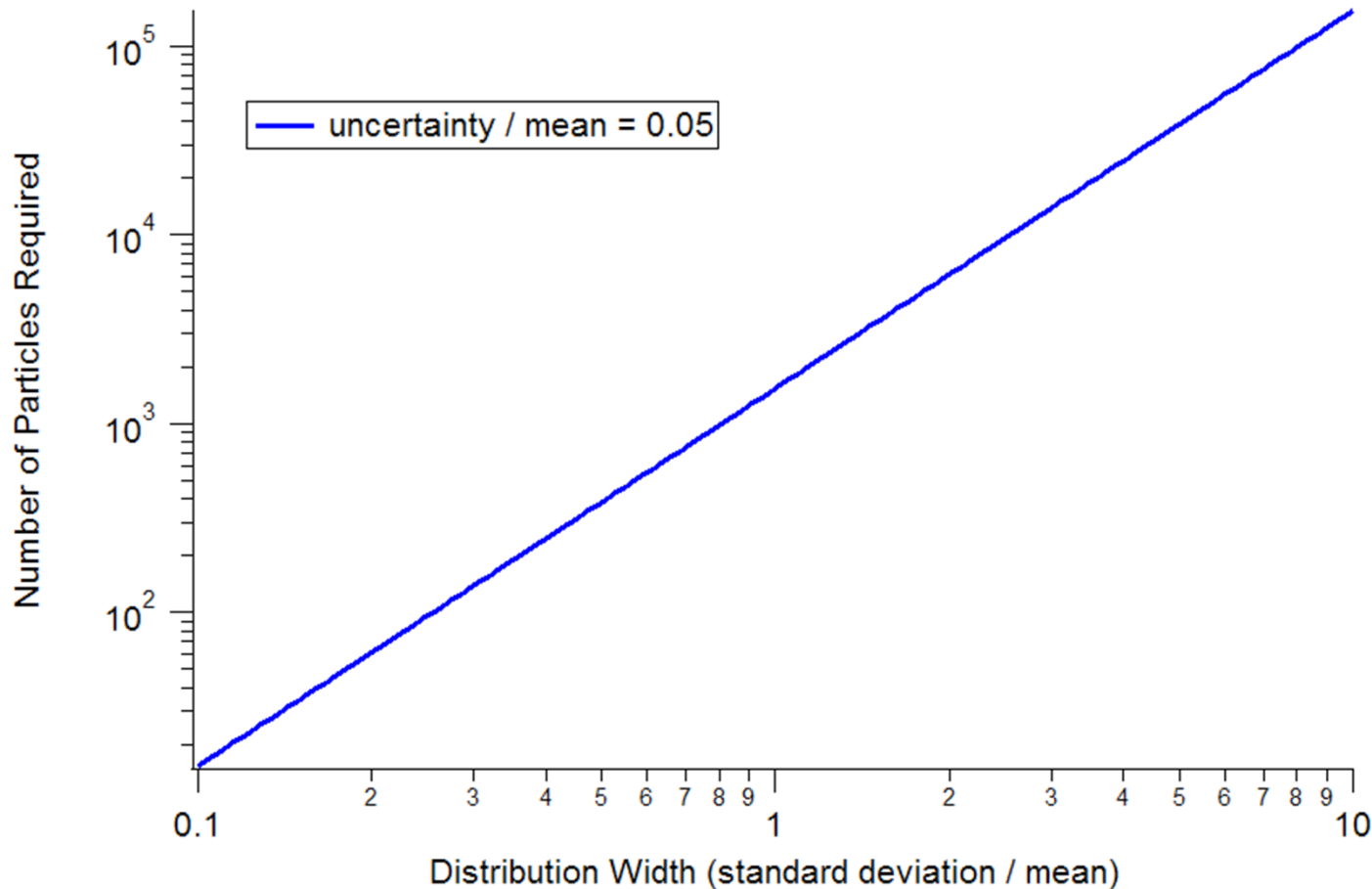
s=estimated standard deviation of distribution (width)

n=number of particles measured

These limits are asymmetric around the standard deviation.

Implies normal particle size distribution, greater than 30 particles, and known standard deviation.

How Many Particles?



Some materials have a distribution such that $SD/Mean \sim 1$.

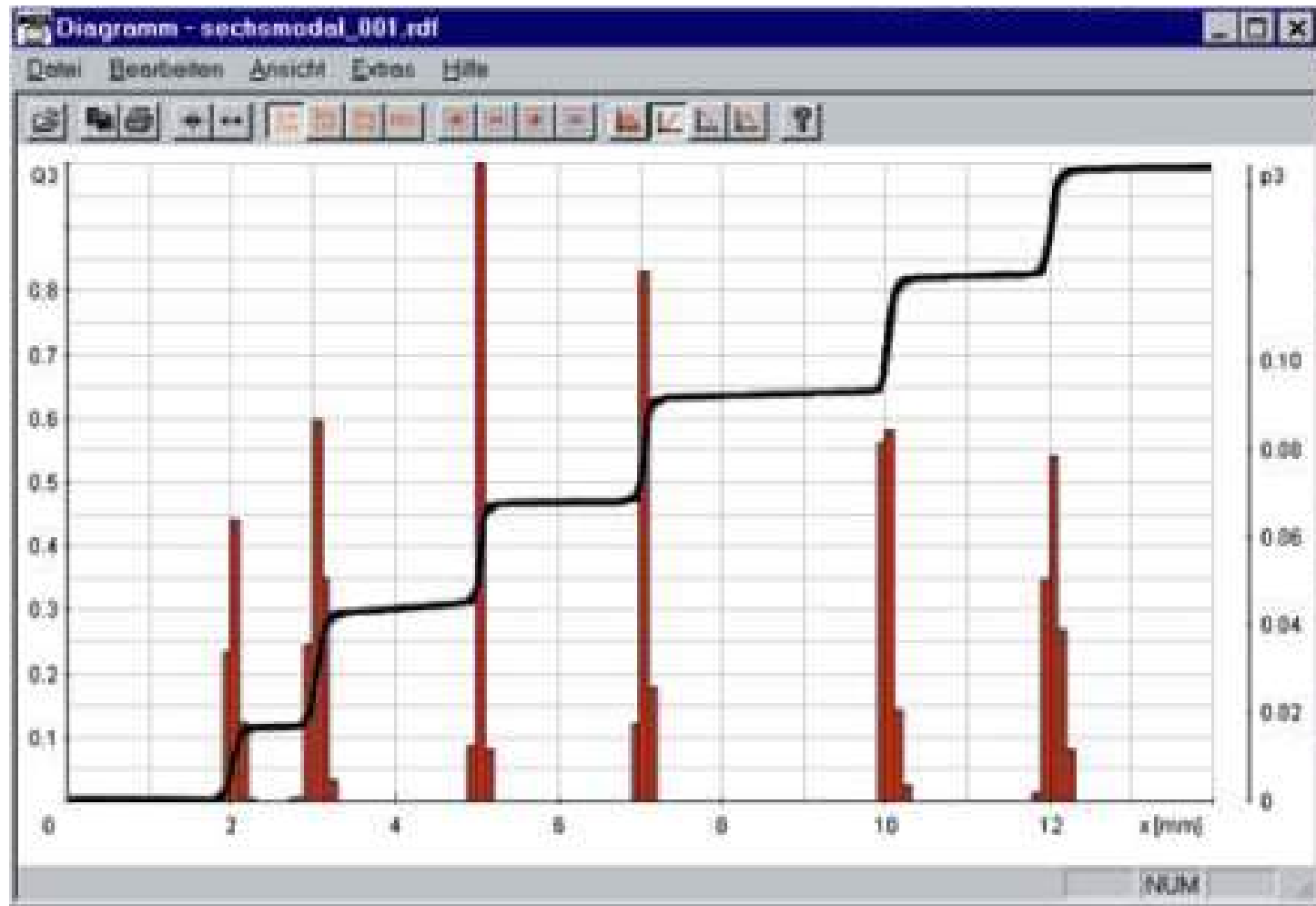
To obtain reliable mean values, measure ~1500 particles.

To obtain more details about the distribution, (10x?) more particles need to be measured.

- Is that the “real size”?
- Image analysis uses actual pictures to extract size.
- Calibration with a reticle.



Resolution



mixture of six sizes of grinding balls

Why dynamic image analysis

- Robust measurement....the interaction between the instrument and the particle is optical, so there is no wear and change in calibration.
- High resolution size distribution results
- Fast

Also, these are all reasons to use Dynamic Image Analysis instead of sieves.

The HORIBA PSA300



■ Turnkey System

- More time getting results and less time engineering

■ Automated

- Faster
- Less operator labor
- Less operator bias

■ Powerful Software Features

- Image Enhancement
- Particle separation

■ Separate Disperser Option

- More flexible sample preparation



The CAMSIZER

- Measurement of very broad particle distributions
- Direct particle definition
 - by width (analogue to sieving)
 - by length
 - or projection surface
- Two camera system for more accuracy/wider range
- Easy operation
- Fail-safe, robust
- Ideal for particle shape analyses
- Measurement of density, counting of particles



Static or Dynamic Image Analysis?

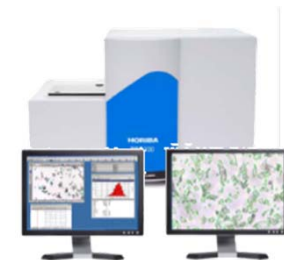
■ Dynamic

- Broad size distributions (since it is easier to obtain data from a lot of particles)
- Samples that flow easily (since they must be dropped in front of camera)
- Powders, pellets, granules



■ Static

- Samples that are more difficult to disperse (there are more methods for dispersing the samples)
- Samples that are more delicate
- Pastes, sticky particles, suspensions




Conclusions

- Image Analysis is good for
 - Replacing Sieves
 - Size
 - Shape
 - Supplementing other techniques
- Watch out for
 - Sample preparation
 - Image quality
 - Measure enough particles



Questions?

www.horiba.com/us/particle



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